

DeltaGT MI 3309 BT Instruction manual Ver. 1.1, Code no. 20 752 183



Distributor:

Manufacturer:

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1 General description

The multifunctional portable appliance tester DeltaGT is intended to perform measurements for testing the electrical safety of portable electrical equipment. The following tests can be performed:

- visual inspection;
- earth continuity resistance;
- insulation resistance;
- insulation resistance of isolated accessible conductive parts;
- substitute leakage current;
- substitute leakage current of isolated accessible conductive parts;
- IEC cord polarity test;
- differential leakage current test;
- touch leakage test;
- RCD and PRCD tests, also PRCD-K and PRCD-S;
- power test;
- TRMS voltage;
- clamp current;
- functional test.

Some instrument's highlights:

- Power supply from both mains power and batteries;
- graphic LCD with resolution of 128 x 64 dots, with backlight;
- large data flash memory for storing test results and parameters (approx. 1500 tests can be stored);
- two communication ports (USB and RS232C) for communication with PC, barcode scanner, printer and RFID reader/writer;
- Bluetooth communication with PC, printers, and Android devices;
- additional connectors for fixed appliances testing;
- built-in real time clock;
- fully compatible with new METREL PATLink PRO PC software package;

Powerful functions for fast and efficient periodic testing are included:

- pre-programmed test sequences;
- fast testing with the help of barcodes and RFID tags;
- custom test sequences can be uploaded from PC.

The graphic display with backlight offers easy reading of results, indications, measurement parameters and messages. Two LED Pass/Fail indicators are placed at the sides of the LCD.

The unit is very intuitive to use and has help menus describing how to perform each test. The operator therefore does not need any special training (except reading this instruction manual) to operate the instrument.

1.1 Warnings

In order to reach a high level of operator safety while carrying out various measurements using the instrument, as well as to keep the test equipment undamaged, it is necessary to consider the following general warnings:

- Warning on the instrument means »Read the Instruction manual with special care to safety operation«. The symbol requires an action!
- Read this instruction manual carefully, otherwise use of the instrument may be dangerous for the operator, for the instrument or for the equipment under test!
- If the test equipment is used in manner not specified in this instruction manual the protection provided by the equipment may be impaired!
- Do not use the instrument and accessories if any damage is noticed!
- Do not touch any test leads/terminals while the appliance is connected to the MI 3309 BT DeltaGT.
- Consider all generally known precautions in order to avoid risk of electric shock while dealing with hazardous voltages!
- Use only correctly earthed mains outlets to supply the instrument!
- The mains supply voltage has to be higher than 80 V a.c. otherwise the internal power supply could be damaged.
- Use only standard or optional test accessories, supplied by your distributor!
- Instrument servicing and adjustment have to be carried out by competent authorized personnel!
- Hazardous voltages can exist inside the instrument. Disconnect all test leads, remove the power supply cable and switch off the instrument before opening the battery compartment.
- Instrument contains rechargeable NiCd or NiMh battery cells. The cells should only be replaced with the same type as defined on the battery placement label or in this manual. Do not use alkaline battery cells.
- If a test code with an earth continuity test current higher than 200 mA is selected (manually, with barcode scanner or with RFID reader/writer) the DeltaGT instrument will automatically perform the Earth continuity test with a 200 mA test current. Other test parameters remain unchanged. The operator must be competent to decide if performing the test with a 200 mA current is acceptable!

1.2 Battery and charging

The instrument uses six AA size rechargeable NiCd or NiMH battery cells. Alkaline battery cells are not allowed.

Battery condition is always displayed in the upper right corner of the display.

If the battery power becomes too weak, the instrument indicates this as shown in *Figure* **1.1**. This indication appears for a few seconds and then the instrument turns itself off.

BATTE	RY TEST	
حم		
	TOO LOW 6.6V	

Figure 1.1: Discharged battery indication

The battery is charged whenever the instrument is connected to mains voltage. The instrument automatically recognizes the connection to the mains voltage and begins charging. Internal circuit controls charging and assures maximum battery lifetime.

Symbols:	
÷	Indication of battery charging

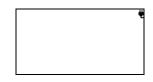


Figure 1.2: Charging indication on display

- ➤ ▲ When connected to an installation, the instruments battery compartment can contain hazardous voltage inside! Before opening the battery compartment cover, disconnect all accessories connected to the instrument and switch off the instrument.
- Ensure that the battery cells are inserted correctly otherwise the instrument will not operate and the batteries could be discharged.
- If the instrument is not to be used for a long period of time, remove all batteries from the battery compartment.
- Rechargeable NiCd or NiMH batteries type HR 6 (size AA) can be used. Metrel recommends only using rechargeable batteries with a capacity of 2100mAh or higher.

1.3 New battery cells or cells unused for a longer period

Unpredictable chemical processes can occur during the charging of new battery cells or cells that have been left unused for a longer period (more than 3 months). NiMH and NiCd cells can be subjected to these chemical effects (sometimes called the memory effect). As a result the instrument operation time can be significantly reduced during the initial charging/discharging cycles of the batteries.

In this situation, Metrel recommend the following procedure to improve the battery lifetime:

Procedure	Notes
 Completely charge the battery. 	At least 14h with the in-built charger.
 Completely discharge the battery. 	This can be performed by using the instrument normally until the instrument is fully discharged.
 Repeat the charge / discharge cycle at least 2-4 times. 	Four cycles are recommended in order to restore the batteries to their normal capacity.

Note:

- The charger in the instrument is a pack cell charger. This means that the battery cells are connected in series during the charging. The battery cells have to be equivalent (same charge condition, same type and age).
- One different battery cell can cause an improper charging and incorrect discharging during normal usage of the entire battery pack (it results in heating of the battery pack, significantly decreased operation time, reversed polarity of defective cell,...).
- If no improvement is achieved after several charge / discharge cycles, then each battery cell should be checked (by comparing battery voltages, testing them in a cell charger, etc). It is very likely that only some of the battery cells are deteriorated.
- The effects described above should not be confused with the normal decrease of battery capacity over time. Battery also loses some capacity when it is repeatedly charged / discharged. Actual decreasing of capacity, versus number of charging cycles, depends on battery type. This information is provided in the technical specification from battery manufacturer.

1.4 Standards applied

The DeltaGT is manufactured and tested in accordance with the following regulations:

Electromagnetic compatibility (EMC)			
EN 61326	Electrical equipment for measurement, control and laboratory use – EMC requirements Class B (Hand-held equipment used in controlled EM environments)		
Safety (LVD)			
EN 61010-1	Safety requirements for electrical equipment for measurement, control and laboratory use – Part 1: General requirements		
EN 61010-2-030	Safety requirements for electrical equipment for measurement, control and laboratory use – Part 2-030: Particular requirements for testing and measuring circuits		
EN 61010-031	Safety requirements for electrical equipment for measurement, control and laboratory use – Part 031: Safety requirements for hand-held probe assemblies for electrical measurement and test		
EN 61010-2-032	Safety requirements for electrical equipment for measurement, control, and laboratory use - Part 2-032: Particular requirements for hand-held and hand-manipulated current sensors for electrical test and measurement		
Functionality			
EN 61557	Electrical safety in low voltage distribution systems up to 1000 V_{AC} and 1500 V_{AC} – Equipment for testing, measuring or monitoring of protective measures Part 2 Insulation resistance Part 4 Resistance of earth connection and equipotential bonding		
VDE 0404-1	Testing and measuring equipment for checking the electric safety of electric devices - Part 1: General requirements		
VDE 0404-2	Testing and measuring equipment for checking the electric safety of electric devices - Part 2: Testing equipment for tests after repair, change or in the case of repeat tests		
Other reference standards for testing portable appliances			
VDE 0701-702	Inspection after repair, modification of electrical appliances – Periodic inspection on electrical appliances		

NEN 3140 General requirements for electrical safety Guidelines for safe working practices The IEE Code of Practice for In-service Inspection and Testing of Electrical Equipment 3rd edition

Note about EN and IEC standards:

Text of this manual contains references to European standards. All standards of EN 6XXXX (e.g. EN 61010) series are equivalent to IEC standards with the same number (e.g. IEC 61010) and differ only in amended parts required by European harmonization procedure.

2 Instrument description

2.1 Front panel



Figure 2.1: Front panel

Legend:

1	LCD	128 x 64 dots matrix display with backlight.	
2	FAIL	Red indicator Indicates PASS / FAIL of result.	
3	PASS	Green indicator	
4	TEST	Starts testing / confirms selected option.	
5	UP	Selects parameter / changes value of selected parameter.	
6	DOWN		
7	MEM	Store / recall / clear tests in memory of instrument.	
8	TAB	Selects the parameters / item / option in selected function.	
		Switches the instrument power on or off.	
		To switch the instrument Off the key must be pressed for 2	
~	ON / OFF	seconds.	
9	ESC	The instrument automatically turns off in 15 minutes after the	
		last key was pressed.	
		Returns to previous level.	
10		Test socket.	

2.2 Connector panel

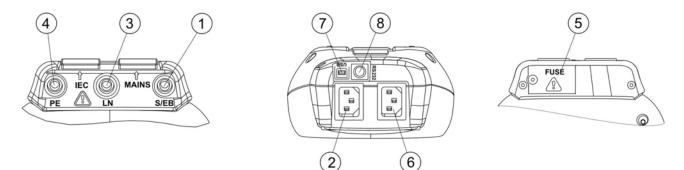


Figure 2.2: Connector panel

Legend:	
1 S/EB	Probe and Earth continuity terminal
2 IEC	IEC test terminal
3 LN	LN terminal (for connection of fixed installed appliances)
4 PE	PE terminal (for connection of fixed installed appliances)
5 FUSE compartment	Fuses: 2 x T16 A / 250 V; breaking capacity: 1500 A
	(for protection against overload and short circuit)
6 MAINS	Mains supply connector and test terminal.
	(Used for charging, Voltage and (P)RCD tests also)
7 USB connector	Communication with PC USB (1.1) port.
	Communication with barcode scanner.
	Communication with printer.
8 PS/2 connector	Communication with RFID reader/writer.
	Communication with PC RS232 port.
	Initialization of Bluetooth Dongle.

Warning:

Maximum allowed voltage on MAINS terminal is 300 V (CAT II)!

2.3 Back side



Figure 2.3: Back side

Legend:

- 1 Inserts for side belt
- 2 Battery compartment cover
- Fixing screw for battery compartment cover 3
- Back side information label 4
- Holder for inclined position of the instrument 5



Figure 2.4: Battery compartment

Legend:

Type HR 6 (size AA), rechargeable NiMH / NiCd Battery cells 1

2.4 Meaning of symbols and messages on the instrument display

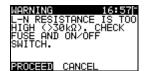
Before performing a measurement, the instrument performs a series of pre-tests to ensure safety and to prevent any damage. These safety pre-tests are checking for any external voltage and load condition on test terminals. If a pre-test fails, an appropriate warning message will be displayed. Warnings and protective measures are described in this chapter.

WARNING! 05:54 JARNING Improper supply voltage warning. Possible causes: WRONG VOLTAGE SYSTEM no earth connection or other wiring problem on supply socket, instrument is connected to 110 V or IT earthing • supply system. ARNING 12:22 WARNING! NO VOLTAGE No voltage was detected on the mains input. Check mains connection. WARNING! A low resistance of the appliance' supply input was 12:10 measured in the pre-test. This means that most likely a ISTANCE high current will flow after applying power to the tested appliance. If the high current is only of short duration PROCEED CANCEL (caused by a short inrush current) the test can be performed, otherwise not. Select PROCEED or CANCEL. WARNING! A very low resistance of the appliance' supply input was measured in the pre-test. It is likely that fuses will blow WARNING 05:50 after applying power to the tested appliance. If the too high -N RESISTANCE JERY LOW (<3Ω) current is only of short duration (caused by an inrush current) the test can be performed otherwise it must be PROCEED CANCEL stopped. Select **PROCEED** or **CANCEL**. It is recommended to additionally check the appliance before proceeding with the test! WARNING! 20:520 HORNING A high leakage current (higher than 3.5 mA) will flow if EB IS power would be connected to the tested appliance. Select PROCEED or CANCEL. Proceed with testing only if all safety measures have been taken. JARNING 12:300

WARNING!

∕EB IS TOO

A dangerous leakage current (higher than 20 mA) will flow if power would be connected to the tested appliance. The instrument blocks the test.







OUT OF CUSTOM AUTOTEST MEMORY



OUT OF MEMORY













WARNING!

A high resistance between L and N was measured in the fuse pre-test. This indication means that the device under test has very low power consumption or it is:

- not connected;
- switched off:
- contains a fuse that has blown.

Select PROCEED or CANCEL.

WARNING!

Voltage on test socket or IEC test terminal is higher than approximately 20 V (AC or DC)!

Disconnect the device under test from the instrument immediately and determine why an external voltage was detected!

WARNING!

The custom autotest memory has reached the limit of 50 sequences.

WARNING!

The internal memory is full!

WARNING!

The calibration period will expire in less than 1 month. The instrument counts down the days.

WARNING!

The calibration period has expired. Recalibrate the instrument!

PE between test socket and IEC test terminal is not connected!

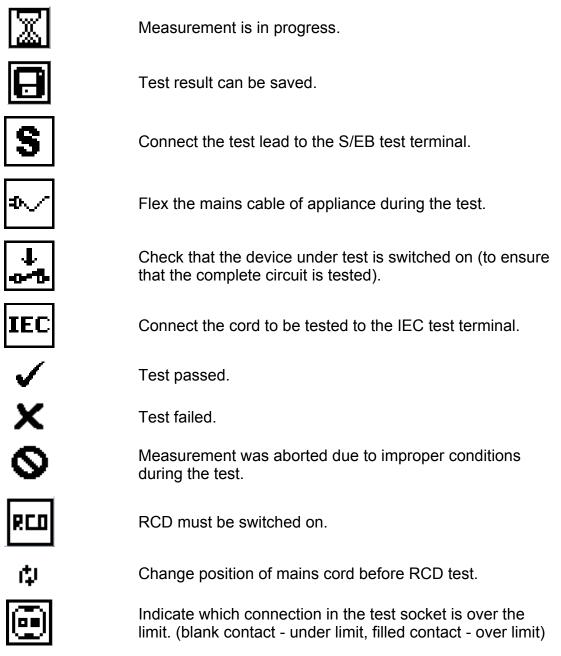
The instrument detects a serious failure. Switch OFF the instrument. Disconnect all cables and leads. Switch ON the instrument again. Return the instrument to the repair centre if the message is displayed again.

WARNING!

A high voltage will be present on the output of the instrument!

WARNING!

A high insulation test voltage is present on the output of the instrument.



2.4.1 Battery indication

The indication shows the charge condition of battery and connection of external charger.

	Battery capacity indication.
0	Low battery. Battery is too weak to guarantee correct result. Replace or recharge the battery cells.
ŧ	Instrument is connected to the mains (and is charging)

3 Technical specifications

3.1 Earth continuity

Range	Resolution	Accuracy
$0.00 \ \Omega \div 19.99 \ \Omega$	0.01 Ω	\pm (5 % of reading + 3 digits)
20.0 Ω ÷ 199.9 Ω	0.1 Ω	Indication only
200 Ω ÷ 1999 Ω	1Ω	Indication only

Powered by	battery or mains
Test currents	200 mA into 2.00 Ω
Open circuit voltage	<9 V AC
Pass levels	0.10 Ω, 0.20 Ω, 0.30 Ω, 0.40 Ω, 0.50 Ω, 0.60 Ω, 0.70 Ω,
	0.80 Ω, 0.90 Ω, 1.00 Ω, 1.50 Ω, 2.00 Ω
Test duration	2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s
Test method	2-wire measurement
Test terminals	PE (Test socket) ↔ S/EB (probe)
	$PE(IEC Cord) \leftrightarrow PE(Test socket)$
	PE (terminal) \leftrightarrow S/EB (probe) (for fixed installed
	appliances)

3.2 Insulation resistance, Insulation – P resistance

Range	Resolution	Accuracy
$0.00 \text{ M}\Omega \div 19.99 \text{ M}\Omega$	0.01 MΩ	(E) of reading 1.2 digita)
$20.0 \text{ M}\Omega \div 49.9 \text{ M}\Omega$	0.1 MΩ	\pm (5 % of reading + 3 digits)
50.0 MΩ ÷ 199.9 MΩ	0.1 MΩ	Indication only

Powered by Nominal voltages	battery or mains 250 V DC, 500 V DC (- 0 %, + 10 %)
	min. 1 mA at 250 kΩ (250 V), 500 kΩ (500 V)
Short circuit current	max. 2.0 mA
Pass levels	0.01 ΜΩ, 0.10 ΜΩ, 0.25 ΜΩ, 0.30 ΜΩ, 0.50 ΜΩ, 1 ΜΩ, 2
	ΜΩ, 4 ΜΩ, 7 ΜΩ, 10 ΜΩ, ΜΩ
Test duration	2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s
Test terminals (Insulation)	LN (Test socket) ↔ PE (Test socket)
	LN (terminal) \leftrightarrow PE (terminal) (for fixed installed
	appliances)
	LN (Test socket) ↔ S/EB (probe)
	LN (terminal) \leftrightarrow S/EB (probe) (for fixed installed
	appliances)

Test terminals (Insulation-P) LN (Test socket) \leftrightarrow S/EB (probe)

LN (terminal) \leftrightarrow S/EB (probe) (for fixed installed appliances)

3.3 Substitute leakage current

Range	Resolution	Accuracy
0.00 mA ÷ 9.99 mA	0.01 mA	(E % of reading 1.2 digita)
10.0 mA ÷ 20.0 mA	0.1 mA	\pm (5 % of reading + 3 digits)

Powered by Open circuit voltage Short circuit current Pass levels:	<50 V AC at rated mains voltage
Substitute leakage	0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA, 2,25 mA, 2.50 mA, 3.50 mA, 4.00 mA, 4.50 mA, 5.00 mA, 5.50 mA, 6.00 mA, 7.00 mA, 8.00 mA, 9.00 mA, 10.0 mA, 15.0 mA, mA
	2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s calculated to appliance nominal mains supply voltage (230 V)
Test terminals (Sub. leakage).	LN (Test socket) ↔ PE (Test socket) LN (terminal) ↔ PE (terminal) (for fixed installed appliances) LN (Test socket) ↔ S/EB (probe)
	LN (terminal) \leftrightarrow S/EB (probe) (for fixed installed appliances)

3.4 Substitute leakage – P current

Range	Resolution	Accuracy
0.00 mA ÷ 4.99 mA	0.01 mA	\pm (5 % of reading + 3 digits)

Powered by Open circuit voltage Short circuit current Pass levels:	<50 V AC at rated mains voltage
Substitute leakage - P	0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2,00 mA, mA
	2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s calculated to appliance nominal mains supply voltage (230 V)
Test terminals (Sub. leakage-P	P)LN (Test socket) \leftrightarrow S/EB (probe) LN (terminal) \leftrightarrow S/EB (probe) (for fixed installed appliances)

3.5 Polarity test

Powered by Test voltage Detects	<50 V AC PASS, L OPEN, N OPEN, PE OPEN, L-N CROSS, L-N
	SHORT, L-PE SHORT, N-PE SHORT, MULTIPLE FAULT.

Test terminals Test socket \leftrightarrow IEC test terminal

3.6 Differential leakage current

Range	Resolution	Accuracy
0.00 mA ÷ 19.99 mA 0.01 mA		\pm (5 % of reading + 5 digits)
Apparent power Indication	only	
Powered by ma	lins	
Pass levels:		
Test duration:2 s	, 3 s, 5 s, 10 s, 30 s, 60 s, 120	S, S
Frequency response: cor	mplies with EN61010-1 Figure	A1
Test terminals Test	st socket	

Additional error0,01 mA/A

* Measurement is limited to 120 s if ($I_{load} > 10 \text{ A}$).

3.7 Touch leakage current

Range	Resolution	Accuracy
0.00 mA ÷ 7.00 mA	0.01 mA	\pm (10 % of reading + 5 digits)

Apparent power Indication only

Powered by......mains Pass levels:......0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA 2.25 mA, 2.50 mA, 3.50 mA, --- mA Test duration:......2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s Frequency responsecomplies with EN61010-1 Figure A1

Test terminalsTest socket – EB/S test probe

* Measurement is limited to 120 s if (I_{load} > 10 A).

3.8 PRCD and RCD testing

3.8.1 General RCD Trip-out time

Complete measurement range corresponds to EN 61557-6 requirements. Maximum measuring times set according to selected reference for RCD testing.

Range	Resolution	Accuracy
0 ms ÷ 300 ms (½×I∆N)	0.1 ms	1.2 ma
0 ms ÷ 300 ms (I _{ΔN})	0.1 ms	- ±3 ms
0 ms ÷ 40 ms (5×I _{∆N})	0.1 ms	±1 ms

Test terminalsMAINS terminal

Specified accuracy is valid for complete operating range.

3.8.2 Portable RCD trip-out time

Range	Resolution	Accuracy
0 ms ÷ 300 ms(½×I _{∆N})	0.1 ms	1.2 mg
0 ms \div 300 ms (I _{ΔN})	0.1 ms	—±3 ms
0 ms ÷ 40 ms (5×I _{∆N})	0.1 ms	±1 ms

Powered by	mains
Test current	$\frac{1}{2} \times I_{\Delta N}$, $I_{\Delta N}$, $5 \times I_{\Delta N}$ ($I_{\Delta N}$ = 10 mA, 15 mA, 30 mA)
Start angle	. 0°, 180°, both
Test modes	single, autotest

Test terminalsTest socket - IEC test terminal

Specified accuracy is valid for complete operating range.

3.9 Power

Apparent power

Range	Resolution	Accuracy
0.00 kVA ÷ 4.00 kVA	0.01 kVA	\pm (5 % of reading + 3 digits)

Current

Range	Resolution	Accuracy
0.00 A ÷ 16.00 A	0.01 A	\pm (5 % of reading + 3 digits)

Powered by..... mains

Test duration:......2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s

Test terminals MAINS terminal

* Measurement is limited to 120 s if $(I_{load} > 10 \text{ A})$.

3.10 TRMS Voltage

Range	Resolution	Accuracy
80 ÷ 300 V	1 V	\pm (2 % of reading + 2 digits)

Result type True r.m.s. Nominal frequency range 0 Hz, 50 Hz ÷ 60 Hz Frequency accuracy Indication only

Test terminals MAINS terminal

3.11 Clamp current

Range	Resolution	Accuracy*
0.00 mA ÷ 9.99 mA	0.01 mA	\pm (5 % of reading + 10 digits)
10.0 mA ÷ 99.9 mA	0.1 mA	\pm (5 % of reading + 5 digits)
100 mA ÷ 999 mA	1 mA	\pm (5 % of reading + 5 digits)
1.00 A ÷ 9.99 A	0.01 A	\pm (5 % of reading + 5 digits)
10.0 A ÷ 16.0 A	0.1 A	\pm (5 % of reading + 5 digits)

*It does not consider accuracy of current transformer.

Temperature coefficient outside reference temperature limits is 1 % of measured value per $^\circ\text{C}$

3.12 General data

	9 V_{DC} (6×1.2 V NiMH or NiCd battery, type HR 6)
(size AA) Operation	typical 8 h
Battery charging current	
Overvoltage category	CAT II / 300 V
Protection classification Pollution degree Protection degree case Protection degree test connectors	2 IP 40
Display	128 x 64 dots matrix display with backlight
Dimensions (w \times h \times d) Weight	
Reference conditions: Reference temperature range Reference humidity range	
Operation conditions: Working temperature range Maximum relative humidity	0 °C ÷ 40 °C 95 %RH (0 °C ÷ 40 °C), non-condensing
Storage conditions: Temperature range Maximum relative humidity	
	ould be at most the error for reference conditions unction) +1 % of measured value + 1 digit, unless particular function.
Memory	1500 memory locations
Communication transfer speed: RS232 interface RS232 connector USB interface USB connector Bluetooth interface	115200 bps type B
 Protection pre-tests: External voltage between LN a Excessive leakage between S/ L-N resistance is low or very lo 	EB and PE (DC and AC).
Connectivity (fuse) pre-test: Appliance is not switched on or	r there is too high resistance between L and N.
Maximum resistance for connectivity	-
	22

4 Main menu and test modes

4.1 Instrument Main menu

From the Main menu of the instrument there are five instrument operation modes, Help menu and Setup menu can be selected:

MAIN MENU	13:33
VDE ORGANIZE	R
SINGLE TEST	
CUSTOM AUTOT	EST
SIMPLE TEST	-
↓CODE AUTOTES	

MAIN MENU	13:33
CUSTOM AUTO SIMPLE TEST	TEST
CODE AUTOTES	ЗΤ
HELP ISETUP	

Figure 4.1	Instrument	Main menu
------------	------------	-----------

Keys:

V/A	Select one of the following menu items:
ТАВ	VDE ORGANIZER> pre-programmed test sequences according to the VDE 0701-0702 norm, see <i>chapter 6.1 VDE organizer setup menu</i> ;
	< SINGLE TEST > individual tests, see <i>chapter 5 Single test</i> ;
	CUSTOM AUTOTEST > user defined pre-programmed sequences, see chapter 6.2 Custom autotest;
	<simple test=""> simple pre-programmed sequences, see chapter 6.3 Simple test</simple>
	CODE AUTOTEST > code-based test sequences, suitable for working with barcodes, QR codes and RFID tags, see <i>chapter 6.4 Code Autotest</i> , CODE AUTOTEST > help screens;
	SETUP > menu for setup of the instrument, see <i>chapter 4.8</i> Setup menu;
TEST	Confirms selection.

4.2 VDE Organizer menu

This menu offers creation and performing of VDE compatible test sequences. The sequence setup and its parameters are the same as suggested in the VDE 0701-0702 standard. After an autotest sequence has been created in the VDE organizer, it can be run as an autotest or stored in the Custom Autotest menu.

VDE ORGANIZER	18:45
Appliance	
General	

Figure 4.2: VDE organizer menu

See chapter 6.1 VDE organizer setup menu for more information.

4.3 Single test menu

In single test menu individual tests can be performed.

SINGLE TEST	12:02
VISUAL INSPEC	ст.
EARTH CONT.	
SUB. LEAKAGE	
INSULATION INSULATION-P ↓SUB. LEAKAGE	

Figure 4.3: Single test menu

See chapter 5 Single test for more information.

4.4 Custom Autotest menu

This menu contains a list of custom prepared autosequences. The commonly used autotest sequences are added to the list by default. Up to 50 custom autotest sequences can be pre-programmed in this autotest mode. Custom autotest can also be uploaded from the PC SW PATLink PRO **Plus**.

CUSTOM AUTOTEST12:10	
Kl_1_Iso	
K1_1_Iso_BLT	
Kl_1_Ia	
Kl_1_Ia_BLT •Kl_2_Iso	
4 (11221130	

Figure 4.4: Custom Autotest menu

See chapter 6.2 Custom autotest for detailed description of this test mode.

4.5 Simple test menu

This menu contains a list of simple test sequences.

SIMPLE	TEST	06:00
CLASS	I	
CLASS		
LLHSS	111	

Figure 4.5: Simple test menu

See chapter 6.3 Simple test for detailed description about this test mode.

4.6 Code Autotests menu

Code Autotests menu supports operation with predefined test codes, barcodes and RFID tags. Test codes can be selected with the barcode scanner, RFID reader/writer or with the \land / \lor keys. Using Bluetooth dongle and PATLink android application, QR codes can also be scanned.

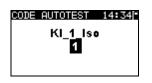
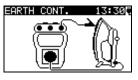


Figure 4.6: Code Autotest menu

See chapter 6.4 Code Autotest for more information.

4.7 Help menu

Help menu contains schematic diagrams to illustrate how to correctly connect a device under test to the PAT testing instrument.



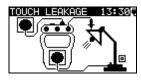


Figure 4.7: Example of help screens

Keys:

A/A	Selects next / previous help screen.
TEST, ESC	Returns to <i>Main menu</i> .

4.8 Setup menu

In the Setup menu different parameters and settings of the instrument can be viewed or set.

SETUP 07:27
MEMORY
LANGUAGE
COMMUNICATION
TEST SPEED SETUP

SETUP 07:27
↑DATE/TIME
USER DATA
INSTRUMENT DATA INIT. SETTINGS
SOUND
000142

Figure 4.8: Setup menu

Keys:

A/A	Select the setting to adjust or view:
	MEMORY> to recall, print or clear stored results, print labels and write
	RFID tags;
	<language> instrument language;</language>
	<communication> Communication and printer settings;</communication>
	<lcd> LCD contrast and backlight settings;</lcd>
	<test setup="" speed=""> to select the speed of the test;</test>
	<date time=""> date and time;</date>
	<user data=""> user data settings (initials);</user>
	<instrument data=""> basic instrument information;</instrument>

	<init. settings=""> factory settings; <sound> sound control.</sound></init.>
TEST	Confirms selection.
ESC	Returns to the <i>Main menu</i> .

4.8.1 Memory

In the Memory menu stored results can be recalled, printed or deleted. Labels can be printed and RFID tags can be written in this menu.

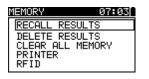


Figure 4.9: Memory menu

See chapter 7 Working with autotest results for more information.

4.8.2 Language selection

The instrument language can be set in this menu.

LANGUAGE	06:00
ENGLISH DEUTSCH	
NEDERLANDS	

Figure 4.10: Language menu

Keys:

V\A	Selects the language.
TEST	Confirms selection and returns to Setup menu.
ESC	Returns to Setup menu without changes.

4.8.3 Communication

In this menu communication ports can be configured and the printer can be set.

COMMUNICATION 14:00 COM PORT: <mark>RS232</mark> PRINTER :ZEBRA BT
COM PORT: RS232
PRINTER :ZEBRA BT
PRN_NAME:ZebraPRN
PRN NAME:ZebraPRN INIT. BT DONGLE (PRN)

Figure 4.11: Communication menu

Options:

COM PORT	USB: communication with PC RS232: communication with external devices (printer, scanner, RFID reader/ writer, PC)	
PRINTER	Selects the printer (can be a RS232 or Bluetooth printer).	
PRN NAME	Enters menu for searching Bluetooth printer.	
INIT. BT DONGLE (PRN)	Initializes Bluetooth dongle for the printer.	

Keys:

V\A	Selects item to be changed.
TEST	Selects option and confirms.
ESC	Returns to Setup menu. Displayed settings are saved.

Note:

 For operation with some external devices the communication port is reconfigured automatically while communication with the device is active. For example, if a RS232 printer is connected to the output of the instrument it will work regardless how the COM PORT is set.

4.8.3.1 Searching for the Bluetooth printer and pairing with instrument

In the *Searching menu* a Bluetooth printer can be found, selected and paired with the instrument.

SEARCHING	
ZebraPRN	
PR 07034	

Figure 4.12: Selection of Bluetooth printer

Keys:

V\A	Selects the printer from the list of found Bluetooth devices.
TEST	Confirm selection of a printer (eg. ZebraPRN).
ESC	Returns to Communication menu without selection of a printer.

Notes:

- This operation must be performed when working with the printer for the first time or if the printer was changed.
- Bluetooth printers can also be operated from some Metrel Android applications. In this case the Bluetooth printer must be selected and paired with the instrument and the Android device. For more information refer to chapter *8.3 Bluetooth communication* and Metrel Android application manual.

4.8.3.2 Initialization of the Bluetooth dongle

Initialization procedure (Bluetooth dongle for the printer):

1. Connect printer's Bluetooth dongle A 1436 to the instrument's PS/2 port.

2. Press RESET key on the Bluetooth dongle A 1436 for at least 10 seconds.

3. Select INIT. BT DONGLE (PRN) in Communication menu and press TEST.

4. Wait for confirmation message and beep. Following message is displayed if dongle was initialized properly:

EXTERNAL BT DONGLE SEARCHING OK!

5. Connect successfully initialized Bluetooth dongle A 1436 to the printer using RS-232 to PS2 interface cable.

Notes:

- The Bluetooth dongle A 1436 should always be initialized before first use with the printer.
- For more information about communication via Bluetooth refer to chapter 8. Communication and A 1436 manual.

4.8.4 LCD contrast and backlight

In this menu the contrast and backlight mode of the LCD can be set.

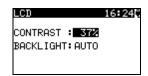


Figure 4.13: LCD contrast menu

Backlight modes:

AUTO	The high backlight level is active for 30 seconds after last pressing of any key.
	Then the backlight level returns to low level until a key is pressed again.
OFF	Backlight level is low.
ON	Backlight level is high.
Kaya	

Keys:

TAB	Toggles between setup of contrast and backlight	
V/A	Sets contrast value or backlight mode	
TEST	TEST Confirms selection and returns to Setup menu.	
ESC	Returns to Setup menu without changes.	

Note:

- If you press the down (♥) key while starting up the instrument you will automatically jump to the LCD contrast menu.
- While the instrument is connected to mains voltage the backlight is automatically switched to the HIGH level.

4.8.5 Test speed setup

In this menu the instrument test speed can be set:

TEST SPEED SET12:14 APPLIED ONLY IN SIMPLE TEST	
STANDARD FAST	

Figure 4.14: Test speed menu

Options:

STANDARD	Default option.	
FAST	No pauses during tests (default).	

Keys:

V\A	Selects the speed mode.
TEST	Confirms selection and returns to Setup menu.
ESC	Returns to Setup menu without changes.

Note:

• When enabling the fast mode then Visual inspection and Functional Test will be automatically set to PASS.

4.8.6 Setting date and time

Date and time can be set in this menu.



Figure 4.15: Date and time menu

Keys:

TAB	Selects the field to be changed.
×/×	Modifies selected field.
TEST	Confirms selection and returns to Setup menu.
ESC	Returns to Setup menu without changes.

Note:

• Date is attached to each stored autotest result.

Warning:

 If the batteries are removed for more than 1 minute the set time and date will be lost.

4.8.7 User data

User data can be set in this menu.

USER DATA 12:32	
USER1: DARREN	
USER2:	
USER3:	
TEST SELECT TABEDIT	

Figure 4.16: User data menu

Keys:

V/A	Selects the user name.
TEST	Confirms selection and returns to Setup menu.
ESC	Returns to Setup menu without changes.
TAB	Enters <i>Edit user data menu</i> .

Edit user data:

USER DATA USER NAME:	12:32
DARREN	
MEM SAVE	ESC CLR

Figure 4.17: Edit user data menu

Keys:

V/A	Selects a letter.
TEST	Selects the next letter.
MEM	Confirms name and returns to User data menu .
ESC	Deletes last letter.
	Returns to User data menu without changes.

Notes:

- The selected user will be printed on the simple label (initials).
- Five different user names can be set.

4.8.8 Instrument data

In this menu the following instrument data is shown:

- producer name;
- instrument type;
- model number;
- calibration date;
- serial number;
- firmware and hardware version.

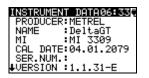


Figure 4.18: Instrument data menu

Keys:

10,00	
×/×	Switches between Instrument data screens.
TEST, ESC	Returns to Setup menu.

4.8.9 Initial settings

In this menu the following instrument parameters can be set to their initial values:

- all measurement parameters in single test mode;
- LCD settings;
- language;
- communication settings;
- internal Bluetooth module is initialized;
- custom autotest sequences are replaced by factory pre-programmed ones.

INIT. SETTINGS 16:53 Contrast, Backlight, Language, Function Parameters will be set to default.
SET

INIT. SETTINGS 07:570 INTERNAL BT MODULE SEARCHING... OK!



Figure 4.19: Initial settings menu

Keys:

TEST	Confirms selection and returns to <i>Main menu</i> .
ESC	Returns to Setup menu without changes.

4.8.10 Sound

In this menu audible indication of fail test result can be enabled / disabled.

SOUND	
OFF	
ON	

Figure 4.20: Sound menu

Keys:

V\A	Select sound option.
TEST	Confirms selection and returns to Setup menu.
ESC	Returns to Setup menu without changes.

5 Single test

In a Single test mode individual tests can be performed. This is especially helpful for troubleshooting.

5.1 Performing measurements in single test mode

Select appropriate test in Single test menu.

SINGLE TEST 14:05C	
VISUAL INSPECT.	
EARTH CONT.	
INSULATION	
INSULATION-P	
↓SUB. LEAKAGE	

Figure 5.1: Single test menu

Keys:

V\A	Selects a single test.
TEST	Enters Single test measuring menu.
ESC	Returns to <i>Main menu.</i>

A single test can be started from any Single test measuring menu. Before carrying out a test the parameters / limits can be edited.

EARTH CONT	17:57[-
R:Ω	
Out: 200mA Lim:0 .10 2 Tim: 2s	₽V S

Figure 5.2: Example of single test measuring menu

Keys:

TAB	Selects a parameter.
×/×	Changes a parameter / limit.
TEST	Starts a single test.
ESC	Returns to Single test menu.

Note:

• Last set parameters will be stored automatically.

Single measurements are stored the same way as autotest results. See chapter 7.1 *Saving autotest results* for more information.

5.2 Measurements and inspections

5.2.1 Visual inspection

A thorough visual check must be carried out before each electrical safety test. The following items should be checked:

- Inspection of the device under test for sign of damage.
- Inspection of the flexible power supply cable for damage.
- Any signs of pollution, moisture, dirt that can jeopardize safety. Especially openings, air filters, protection covers and barriers must be checked!
- Are there signs of corrosion?
- Are there signs of overheating?
- Inscriptions and markings related to safety must be clearly readable.
- Installation of the device under test must be performed according to the instruction manual.
- During visual inspection the measuring points for the electrical testing have to be determined too.

Visual inspection procedure

- Select the VISUAL INSPECT. function.
- Check the device under test.
- Select PASS or FAIL according to the result of visual inspection.
- Store the result by pressing MEM key (optional).





Figure 5.3: Visual inspection menu

5.2.2 Earth continuity resistance

This test ensures that the connections between the protective conductor terminal in the mains plug of the device under test and earthed accessible conductive parts of the device under test are satisfactory and of sufficiently low resistance. This test has to be performed on Class I (earthed) appliances. The instrument measures the resistance between:

- S/EB terminal and PE of the test socket;
- PE of the IEC test terminal and PE of the test socket (for IEC Cords);
- S/EB terminal and PE terminal (for fixed installed appliances).

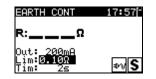


Figure 5.4: Earth continuity menu

Test parameters for Earth continuity resistance measurement

LIMIT	Maximum resistance [0.10 Ω, 0.20 Ω, 0.30 Ω, 0.40 Ω, 0.50 Ω, 0.60 Ω,
	0.70 Ω, 0.80 Ω, 0.90 Ω, 1.00 Ω, 1.50 Ω, 2.00 Ω]
TIME	Measuring time [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s (continuous
	measurement)]

Typical test circuits for Earth continuity resistance measurement



Figure 5.5: Measurement of Earth continuity

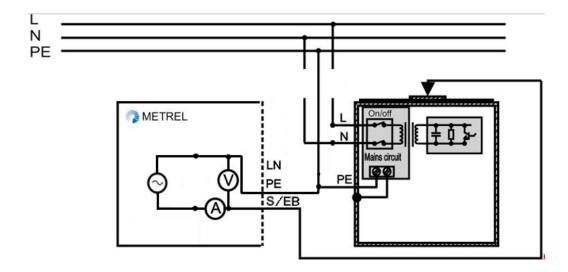


Figure 5.6: Measurement of Earth continuity of fixed installed DUTs of Class I

Earth continuity resistance measurement procedure

- Select the EARTH CONT. function.
- Set the test parameters.
- Connect device under test to the instrument (see *Figure 5.5* and *Figure 5.6*).
- Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- Store the result by pressing MEM key (optional).





Figure 5.7: Examples of Earth continuity resistance measurement results

Displayed results: Main result Earth continuity resistance

Note:

- Consider displayed warnings before starting measurement!
- If the PRCD test is set in the Autotest procedure power is applied to the mains test socket during the earth continuity test. This feature enables to test special types of RCDs (PRCD-K, PRCD-S) where the PE conductor is not connected until power is applied to the device.

5.2.3 Insulation resistance

The insulation resistance test checks the resistance between live conductors and earthed (or isolated) accessible metal parts of a device under test. This test can disclose faults caused by pollution, moisture, deterioration of the insulation material etc.

The instrument measures the insulation resistance between:

- The (L+N) on test socket and PE terminal on test socket / (S/EB) terminal;
- LN terminal and PE terminal / (S/EB) terminal (for fixed installed appliances).

This function is primarily intended for testing Class I appliances.

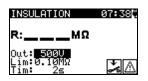


Figure 5.8: Insulation menu

Test parameters for insulation resistance measurement

OUTPUT	Test voltage [250 V, 500 V]
LIMIT	Minimum resistance [0.01 ΜΩ, 0.10 ΜΩ, 0.25 ΜΩ, 0.30 ΜΩ, 0.50 ΜΩ,
	1 ΜΩ, 2 ΜΩ, 4 ΜΩ, 7 ΜΩ, 10 ΜΩ, ΜΩ]
TIME	Measuring time [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s (continuous
	measurement)]

Test circuits for Insulation resistance measurement

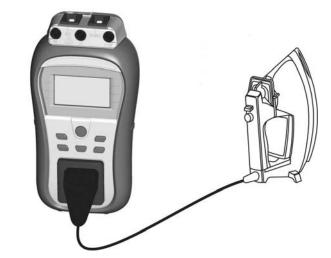


Figure 5.9: Measurement of insulation resistance

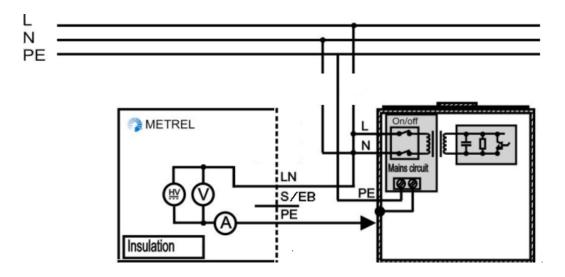


Figure 5.10: Measurement of insulation resistance of fixed installed DUTs of Class I

Insulation resistance measurement procedure

- Select the INSULATION function.
- Set the test parameters.
- Connect device under test to the instrument (see *Figure 5.9* and *Figure 5.10*).
- Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- Store the result by pressing MEM key (optional).





Figure 5.11: Examples of Insulation resistance measurement results

Displayed results: Main result Insulation resistance

Notes:

- When S/EB probe is connected during the test then the current through it is also considered.
- Consider any warning on the display before starting the measurement!
- Do not touch or disconnect the device under test during the measurement or before it is fully discharged! The message »Udisch …« will be displayed while the voltage on the device is higher than 10 V!

5.2.4 Insulation resistance - P

The insulation resistance test checks the resistance between live conductors and isolated accessible metal parts of the device under test. This test can disclose faults caused by pollution, moisture, deterioration of the insulation material etc.

The instrument measures the insulation resistance between:

- The (L+N) on test socket and S/EB terminal;
- LN terminal and S/EB terminal (for fixed installed appliances).

This function is primarily intended for testing Class II appliances and Class II parts of Class I appliances.

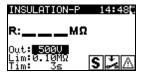


Figure 5.12: Insulation resistance - P menu

Test parameters for Insulation resistance - P measurement

OUTPUT	Test voltage [250 V, 500 V]
LIMIT	Minimum resistance [0.01 MΩ, 0.10 MΩ, 0,25MΩ, 0.30 MΩ, 0.50 MΩ,
	1 ΜΩ, 2 ΜΩ, 4 ΜΩ, 7 ΜΩ, 10 ΜΩ, ΜΩ]
TIME	Measuring time [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s (continuous
	measurement)]

Test circuits for Insulation resistance - P measurement

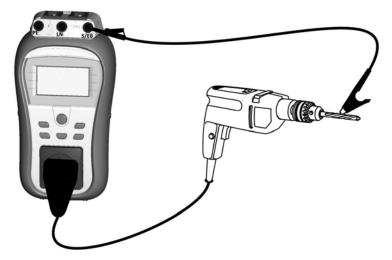


Figure 5.13: Measurement of Insulation resistance - P

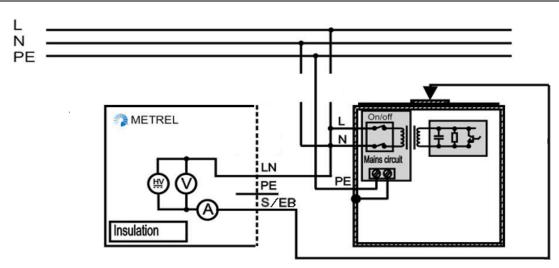


Figure 5.14: Measurement of insulation resistance of fixed installed DUTs

Insulation resistance - P measurement procedure

- Select the INSULATION-P function.
- Set the test parameters.
- Connect device under test to the instrument (see Figure 5.13 and Figure 5.14).
- Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- Store the result by pressing MEM key (optional).





Figure 5.15: Example of insulation resistance - P measurement results

Displayed results:

Main result Insulation resistance (LN – P)

Notes:

- The currents flowing through the PE terminal or PE on test socket will NOT be considered.
- Consider any warning on the display before starting the measurement!
- Do not touch / disconnect the device under test during the measurement or before it is fully discharged! The message »UDisch…« will be displayed while the voltage on the device is higher than 10 V!

5.2.5 Substitute leakage

Leakage currents between live conductors and accessible metal parts (housing, screws, handles etc.) are checked with this test. Capacitive leakage paths are included in the result too. The test measures the current flowing at a test voltage of 30 VAC and the result is scaled to the value of a nominal mains supply voltage.

The instrument measures the substitute leakage between:

- The (L+N) on test socket and PE terminal on test socket / (S/EB) terminal;
- LN terminal and PE terminal / (S/EB) terminal (for fixed installed appliances).
- This function is primarily intended for testing Class I appliances.

SUB. LEAKAGE	07 : 450
l:mA	
Out:30,0V Lim: 0.50mA Tim: 30s	÷*

Figure 5.16: Substitute leakage menu

Test parameters for Substitute leakage current measurement

OUTPUT	Test voltage [30 V]
LIMIT	Maximum current [0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA,
	2.00 mA, 2.25 mA, 2.50 mA, 3.50 mA, 4.00 mA, 4.50 mA, 5.00 mA,
	5.50 mA, 6.00 mA, 7.00 mA, 8.00 mA, 9.00 mA, 10.0 mA, 15.0 mA, mA]
TIME	Measuring time [2s, 3s, 5 s, 10 s, 30 s, 60 s, 120 s, s (continuous
	measurement)]

Test circuits for Substitute leakage current measurement

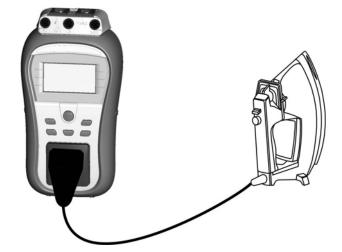


Figure 5.17: Measurement of Substitute leakage current

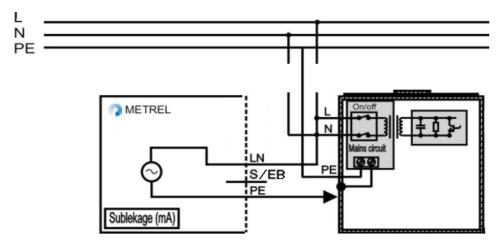


Figure 5.18: Measurement of substitute leakage current of fixed installed DUTs

Substitute leakage measurement procedure

- Select the SUB. LEAKAGE function.
- Set the test parameters.
- Connect device under test to the instrument (see Figure 5.17 and Figure 5.18).
- Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- Store the result by pressing MEM key (optional).

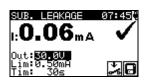




Figure 5.19: Example of substitute leakage current measurement results

Displayed results: Main result Substitute leakage current

Notes:

- Consider any displayed warning before starting measurement!
- When S/EB probe is connected during the test then the current through it is also considered.
- Substitute leakage result may differ from the leakage current test result. For example, if EM filter capacitors are connected to the phase and neutral conductors, the substitute leakage result can be 2 times higher than the differential leakage result.

5.2.6 Substitute leakage - P

Leakage currents between live conductors and isolated accessible metal parts (screws, handles etc.) are checked with this test. Capacitive leakage paths are included in the result too. The test measures the current flowing at a test voltage of 30 V AC and the result is scaled to the value of a nominal mains supply voltage.

- The instrument measures the substitute leakage between:
 - The (L+N) on test socket and S/EB terminal;
 - LN terminal and S/EB terminal (for fixed installed appliances).

This function is primarily intended for testing Class II appliances and Class II parts of Class I appliances.

SUB.	LEAKAGE-P	14:48
l:	mA	
Out:3	0.0V	
Lim: <u>B</u> Tim:	Jenner Je	S 📩

Figure 5.20: Substitute leakage - P menu

Test parameters for substitute leakage - P current measurement

OUTPUT	Test voltage [30 V]	
LIMIT	Maximum current [0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA,	
	2.00 mA, mA]	
TIME	Measuring time [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s (continuous	
	measurement)]	

Test circuits for substitute leakage - P measurement

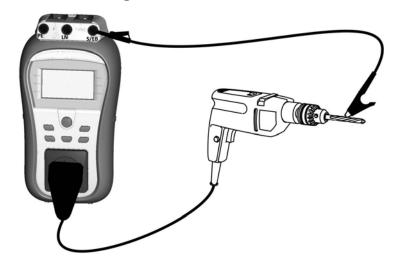


Figure 5.21: Measurement of Substitute leakage - P current

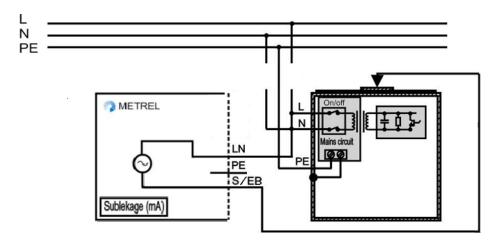


Figure 5.22: Measurement of substitute leakage of accessible isolated conductive parts of fixed installed DUTs

Substitute leakage - P measurement procedure

- Select the SUB. LEAKAGE-P function.
- Set the test parameters.
- Connect device under test to the instrument (see *Figure 5.21* and *Figure 5.22*).
- Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- Store the result by pressing MEM key (optional).



Figure 5.23: Example of substitute leakage - P current measurement results

Displayed results:

Main result.....Substitute leakage current (LN – P)

Notes:

- Consider any displayed warning before starting measurement!
- The currents flowing through the PE terminal or PE of the test socket will not be considered.

5.2.7 Polarity test

This test checks the polarity of supply cords. The following faults can be detected: L OPEN, N OPEN, PE OPEN, L-N CROSS, L-N SHORT, L-PE SHORT, N-PE SHORT and MULTIPLE FAULT.

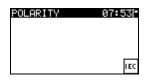


Figure 5.24: Polarity test menu

Test circuit for polarity test





Figure 5.25: Polarity test of IEC cord

Polarity test procedure

- Select the POLARITY function.
- Connect the IEC cord to the instrument as shown on *Figure 5.25*.
- Press the TEST key for measurement.
- Store the result by pressing MEM key (optional).



Figure 5.26: Examples of polarity test result

Displayed results:

Main result PASS/FAIL, description of fault

Note:

Consider any displayed warnings before starting test! •

5.2.8 Differential leakage

The purpose of this test is to determine the sum of all leakages flowing from the live conductors to the earth. The differential method allows measuring the full and true leakage current, even if there are parallel current paths from the DUT to ground.

The instrument measures:

The differential leakage of the DUT connected to the instrument test socket. •

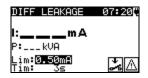


Figure 5.27: Differential leakage current menu

Test parameters for differential leakage current measurement

OUTPUT	Test voltage [MAINS voltage]	
LIMIT	Maximum current [0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA,	
	2.00 mA, 2.25 mA, 2.50 mA, 3.50 mA, 4.00 mA, 4.50 mA, 5.00 mA,	
	5.50 mA, 6.00 mA, 7.00 mA, 8.00 mA, 9.00 mA, 10.0 mA, 15.0 mA, mA]	
TIME	Measuring time [2s, 3s, 5 s, 10 s, 30 s, 60 s, 120 s, s (continuous	
	measurement)]	

Test circuit for differential leakage current measurement

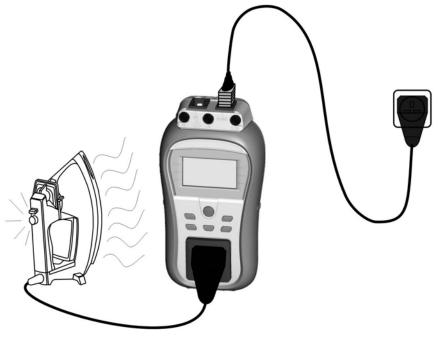


Figure 5.28: Measurement of differential current

Differential current measurement procedure

- Select the DIFF. LEAKAGE function.
- Set the test parameters.
- Connect device under test to the instrument (see *Figure 5.28*).
- Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- Store the result by pressing MEM key (optional).





Figure 5.29: Examples of differential current measurement result

Displayed results: Main result I Differential leakage current Sub-result P...... Apparent power

Notes:

- For this test the instrument must be connected to the mains voltage.
- During the test, mains voltage is connected to the DUT. If DUT contains moving parts, make sure that it is safely mounted or protected to prevent possible danger to the operator or damage to the DUT or surrounding environment!
- Consider any displayed warning before starting measurement!
- The instrument automatically changes L and N polarity of connected DUT during the test.
- Measurement can be aborted by pressing ESC key.

5.2.9 Touch leakage

This test determines the current that would flow if a person touches accessible conductive parts of the DUT.

The instrument measures:

• The touch leakage current flowing through the S/EB probe into earth.

The DUT can be powered from the test socket or directly from the installation (fixed installed equipment).

TOUCH LEAKAGE	14 : 580
l:mA	
P:kVA	
Lim: <mark>0.50mA</mark> Tim: 3s	S 🎿 🛆

Figure 5.30: Touch leakage menu

Test parameters for touch leakage current measurement

OUTPUT	Test voltage [MAINS voltage]	
LIMIT	Maximum current [0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA,	
	2.25 mA, 2.50 mA, 3.50 mA, mA]	
TIME	Measuring time [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s (continuous	
	measurement)	

Test circuits for touch leakage current measurement

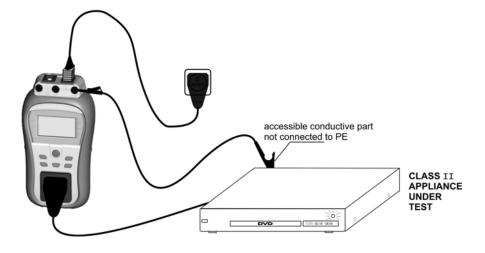


Figure 5.31: Measurement of touch leakage current

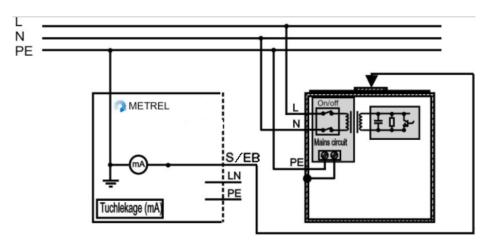


Figure 5.32: Measurement of touch leakage current on a fixed installed DUT

Touch leakage current measurement procedure

- Select the TOUCH LEAKAGE function. ۲
- Set the test parameters. ۲
- Connect device under test to the instrument (see Figure 5.31 and Figure 5.32). ۲
- Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- Store the result by pressing MEM key (optional).



Figure 5.33: Examples of touch leakage current measurement results

S

Displayed results:

Main result I Touch leakage current

Sub-result P.....Apparent power

Notes:

- For this test the instrument must be connected to the mains voltage. ۲
- During the test, mains voltage is connected to the DUT. If DUT contains moving ۲ parts, make sure that it is safely mounted or protected to prevent possible danger to the operator or damage to the DUT or surrounding environment!
- Consider any displayed warning before starting measurement! ۲
- The instrument automatically changes L and N polarity of connected DUT during ۲ the test.
- Measurement can be aborted by pressing ESC key. ۲

5.2.10 (P)RCD test

The purpose of this test is to ensure the proper operation of residual current devices (RCD) built into appliances / installations and portable residual current devices (PRCD). Trip-out time measurement verifies the sensitivity of a (P)RCD at selected residual currents.

The RCD test is performed via the instrument mains supply input.

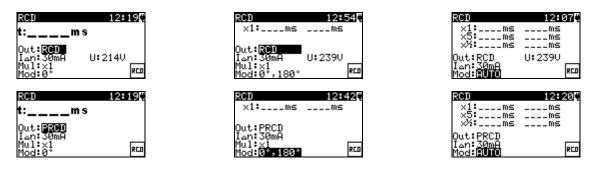


Figure 5.34: (P)RCD single and auto test menus

Test parameters for (P)RCD test

Test	Test function [RCD, PRCD]
$I_{\Delta N}$	Rated residual current [10 mA, 15 mA, 30 mA]
Mul	Test current multiplier $I_{\Delta N}$ [x $\frac{1}{2}$, x 1, x 5]
Mod	(P)RCD test mode [(0°, 180°, (0°,180°), AUTO]

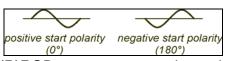
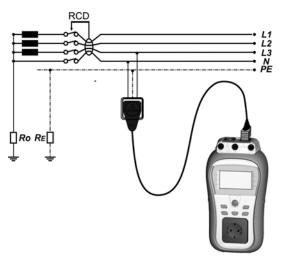
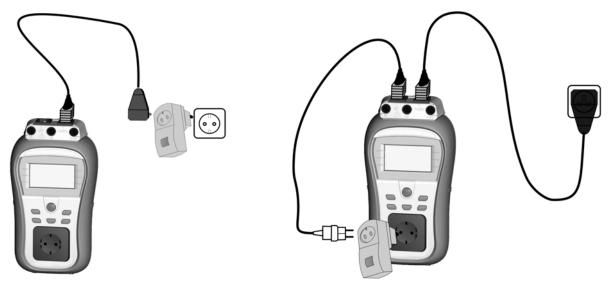


Figure 5.35: (P)RCD test current starting polarities 0°, 180°

Test circuits for testing RCD and PRCD



a) Testing of standard RCD



b) Testing of PRCD via mains socket

c) Testing of PRCD via test socket

Figure 5.36: Testing of RCD and PRCD

5.2.10.1 (P)RCD single test

In single test a fast (P)RCD test with selected test current and with one or both starting polarities is performed.

Trip-out time measurement procedure

Measuring PRCD

- Select the RCD test function.
- Select test mode.
- Set test parameters.
- Connect tested PRCD / device to an external voltage socket. Connect the IEC cord to the instrument's MAINS terminal and PRCD (see *Figure 5.36b*).
- Depending on the type of PRCD, it may be necessary to manually switch it on.
- Press the TEST key to perform measurement.

If both starting polarities are selected:

- Reactivate tested PRCD.
- Store the result by pressing MEM key (optional).
- or
- Select the PRCD test function.
- Select test mode.
- Set test parameters.
- Connect tested PRCD between test socket and IEC connector of the DeltaGT (see *Figure 5.36c*), and connect instrument's MAINS terminal to an external voltage socket.
- Depending on the type of PRCD, it may be necessary to manually switch it on.
- Press the TEST key to perform measurement.
- If both starting polarities are selected:
 - Reactivate tested PRCD.
 - Store the result by pressing MEM key (optional).

Measuring RCD

- Select the RCD test function.
- Select test mode.
- Set test parameters.
- Connect the DeltaGT MAINS terminal to mains socket protected by tested RCD (see *Figure 5.36a*).
- Depending on the type of PRCD, it may be necessary to manually switch it on.
- Press the TEST key to perform measurement.

If both starting polarities are selected:

- Reactivate tested RCD.
- Store the result by pressing MEM key (optional).



800 t:29.1ms	12816
Qut: 2700	•
Ian:30mH Mul:x1 Mod:0°	RCD 🔁

Figure 5.37: Examples of (P)RCD single test results

Displayed results:

Main result(s)...... trip out time(s) at selected starting polarity U voltage U_{L-PE}

5.2.10.2 Automatic (P)RCD test

(P)RCD autotest function is intended to perform a complete (P)RCD analysis (trip-out times at different residual currents and starting polarity phases).

(P)RCD autotest procedure

(P)RC	CD Autotest steps	Notes
•	Select the RCD (PRCD) test function.	
•	Set AUTO mode.	
•	Select test parameters.	
•	PRCD: Connect tested PRCD / device to an external	
	voltage socket. Connect the IEC cord to the	
	instrument's MAINS terminal and PRCD (see Figure	
	5.36b). Or connect tested PRCD between test	
	socket and IEC connector of the DeltaGT Connect	
	the instrument to mains voltage (see <i>Figure 5.36c</i>).	
	Depending on the type of PRCD, it may be	
	necessary to manually switch it on.	
•	RCD: Connect the DeltaGT MAINS terminal to mains	
	socket protected by tested RCD (see <i>Figure 5.36a</i>).	
•	Press the TEST key	
•	Test with $I\Delta N$, 0° (step 1).	(P)RCD should trip-out
•	Re-activate (P)RCD.	
•	Test with I Δ N, 180° (step 2).	(P)RCD should trip-out
•	Re-activate (P)RCD.	
•	Test with 5×I∆N, 0° (step 3).	(P)RCD should trip-out
•	Re-activate (P)RCD.	

•	Test with 5×I∆N, 180° (step 4).	(P)RCD should trip-out
+	Re-activate (P)RCD.	
•	Test with ½×I∆N, 0° (step 5).	(P)RCD should not trip-out
•	Test with $\frac{1}{2} \times I\Delta N$, 180° (step 6).	(P)RCD should not trip-out End of test.

Displayed results:

Main results trip-out times at different currents / starting polarities U voltage U_{I-PF}

Notes:

- Consider any displayed warning before starting measurement! The ¹ symbol means that the polarity of the mains cord should be changed.
- Mains voltage is applied to the (P)RCD under test. Do not touch the equipment under test or the test cord during the test.

5.2.11 Power test

The DUT's power consumption is measured in this test. The apparent power is a useful indication of proper operation of the appliance.

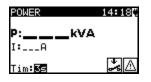


Figure 5.38: Power test menu

Test parameters for the Power test

OUTPUT	Test voltage [MAINS voltage]
TIME	Measuring time [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, s (continuous
	measurement)]

Test circuit for the power test



Figure 5.39: Power test

Power test procedure

- Select the POWER function.
- Set test parameters.
- Connect device under test to the instrument's test socket and switch it on (see figure 5.39).
- Connect the instrument to mains voltage.
- Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- Store the result by pressing MEM key (optional).



Figure 5.40: Example of apparent power measurement result

Displayed results:

P: Apparent power

I:..... complete current into tested appliance

Notes:

- For this test the instrument must be connected to the mains voltage.
- During the test, mains voltage is connected to the DUT. If DUT contains moving parts, make sure that it is safely mounted or protected to prevent possible danger to the operator or damage to the DUT or surrounding environment!
- Consider any displayed warning before starting measurement!
- Continuous measurement is for safety reasons automatically stopped after 2 minutes if a current higher than 10 A is flowing through the DUT and the DeltaGT during Power measurement.

5.2.12 Voltage TRMS

In this function the voltage across the MAINS terminal is measured continuously.

Test circuit for voltage measurement

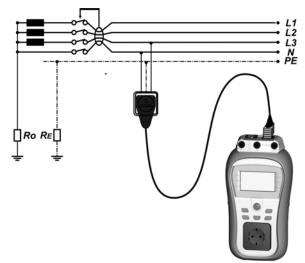


Figure 5.41: Voltage measurement with the IEC cord

Voltage TRMS procedure

- Select the VOLTAGE TRMS function.
- Connect the IEC cord to the instrument's MAINS terminal and to the external mains socket as shown on *Figure 5.41*.
- Store the result by pressing MEM key (optional).

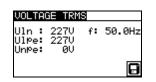


Figure 5.42: Voltage TRMS test result

Displayed results:

Main result Voltage

f..... Frequency

Warning:

• Only for voltage range from 80 V to 300 V!

5.2.13 Clamp current measurement

This function enables the measurement of AC currents in a wide range from 0.1 mA up to 16 A with current clamps. Typical applications are:

- Measuring PE leakage currents through PE conductor in permanently installed appliances,
- Measuring load currents in permanently installed appliances,
- Measuring differential leakage currents in permanently installed appliances.



Figure 5.43: Clamp current menu

Test parameters for clamp current measurement

LIMIT	Maximum current [0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA, 2.25 mA, 2.50 mA, 3.50 mA, 4.00 mA, 4.50 mA, 5.00 mA, 5.50 mA, 6.00 mA, 7.00 mA, 8.00 mA, 9.00 mA, 10.0 mA, 15.0 mA, mA]
TIME	Measuring time [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, none]

Test circuit for clamp current measurement

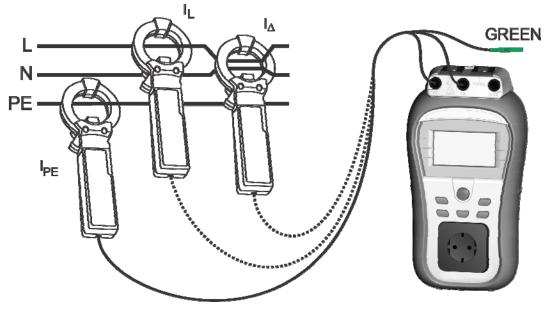


Figure 5.44: Measurement of clamp current

Clamp current measurement procedure

- Select the CURRENT function.
- Set test parameters.
- Connect the current clamp to the instrument (see *Figure 5.44*).
- Embrace wire(s) that has to be measured with the current clamp.
- Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- Store the result by pressing MEM key (optional).





Figure 5.45: Examples of clamp current measurement result

Displayed results: Main result clamp current

Notes:

- When measuring leakage currents, the neighbouring magnetic fields and capacitive coupling (especially from the L and N conductors) can disturb the results. It is recommended that the clamp is as close as possible to the grounded surface and away from wires and other objects under voltage or carrying current.
- METREL offers high quality current clamps for this application.
- Current clamp shield terminal connector (green terminal) can be left open.

5.2.14 Functional test

Functional test is the simplest way to ensure that the appliance is working properly.

Note:

 This test should only be performed once the DUT has passed all other tests applicable to this type of appliances.

Scope of test

Check following items while the appliance is operating:

- RCDs and other disconnection devices.
- How hot the appliance becomes during operation.
- Rotating parts, fans, etc.
- Power consumption.
- Lamps and indicators.
- Etc.

Especially safety relevant functions should be checked.

Functional test procedure

- Select the FUNCTIONAL TEST function.
- Plug the device under test to the instrument's test socket and supply the instrument.
- Select and start **POWER** sub-function. Switch on the appliance and check that it operates correctly.
- Select PASS or FAIL according to the result of functional test.
- Store the result by pressing MEM key (optional).



Figure 5.46: Functional test menu

6 Autotest sequences

Autotest is the fastest and easiest way to test appliances. During the autotest, preprogrammed measurements run automatically in a sequential order. The complete autotest results can be stored together with the associated appliance ID, appliance NAME Re-test period, and Location.

6.1 VDE organizer setup menu

Select VDE Organizer in Main menu.

In the first step the appliance type, protective measures and additional protection should be set.

Appliance types are:

- General;
- Appliances with heating elements.
- IEC leads, multiple outlets without electronic parts;

Protective measures are:

- Accessible conductive part is connected to protective conductor (Class I principle);
- Accessible conductive part is protected by isolation (Class II principle) or SELV / PELV measures;
- Combined Class I and Class II / SELV / PELV measures;
- There are no accessible conductive parts;
- Device is a Class III device.

Additional protection:

- Additional protection is provided by (portable) RCDs;
- No additional protection.

VDE ORGANIZER 16:56	VDE ORGANIZER 16:56	VDE ORGANIZER 12:11
Appliance General	Protective measures Connection with PE conductor - Class I Principle	Other Protective measures ROD

Figure 6.1: Selection of appliance type and protective measures

Keys:		
V/A		
ESC	ESC Cancels VDE sequence and returns to Main menu.	
TEST	Confirms selection and proceeds to next step.	

After the appliance type and means of protection are set the appropriate test sequence can be started.

6.1.1 Carrying out a test sequence set with VDE Organizer

General meaning of keys during VDE Organizer autotest sequence:

\wedge / \vee Sets Organizer option or set value in selected (highlighted) item.
--

ESC Cancels VDE sequence and returns to Main menu.

TEST Starts / repeats selected measurement or proceeds to next step.

After the test sequence is finished the instrument proceeds to the 'Autotest Result' menu. For more information refer to chapter 7 *Working with Autotest results.*

Note:

 If any of the inspections are marked as failed or if any test fails the test sequence is stopped and the instrument automatically goes to the *Result* menu.

6.1.1.1 Visual inspection

Measurement is described in chapter 5.2.1 Visual inspection.



Figure 6.2: VDE Organizer – Visual inspection menu

Options in Visual inspection menu:

PASS / FAIL To be applied manually.

6.1.1.2 Earth continuity resistance measurement

The test is offered if it is applicable according to the VDE Organizer setting. The measurement is described in chapter *5.2.2 Earth continuity resistance*.

EARTH CONT	18:05[-
Cord lengt	h/Limit
< 5m / 0.	30Ω
Out: <u>200mA</u>	
Tim: 55	≉v S

Figure 6.3: VDE Organizer – Earth continuity starting screen

Options in Earth continuity starting screen:

 \land \checkmark Sets power cord length.

Note:

• Earth continuity resistance limit is automatically set on base of set cord length.



Figure 6.4: VDE Organizer – Earth continuity result screen

Options in Earth continuity result screen:

NEXT Proceeds to next step.

REPEAT Repeats the test (in case of multiple earthed points). Highest result will be stored.

6.1.1.3 Insulation resistance measurement

This test is offered if it is applicable according to the VDE Organizer setting. The measurement is described in chapter *5.2.3 Insulation resistance*.

INSULATION	08:04[*
TEST VOL	TAGE
500V	
Out: <mark>5000</mark> Lim: 1ΜΩ Tim: 5s	% A

Figure 6.5: VDE Organizer – Insulation resistance starting screen

Options in insulation resistance starting screen:

ŇO	To be set if insulation test is not applicable
YES	To be set if insulation test is applicable
500 V	Standard test voltage
250 V	To be set if overvoltage protection devices are installed or SELV/ PELV protection measures.



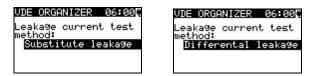
Figure 6.6: VDE Organizer – Insulation resistance result screen

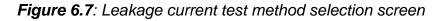
There are no special options to be set in the insulation resistance result screen.

6.1.1.4 Selection of leakage current test method

The leakage test is offered if it is applicable according to the VDE Organizer setting. If more test methods are possible the applicable leakage current test method must be set first.

Options are **Differential leakage** and **Substitute leakage**.





6.1.1.5 Substitute leakage measurement

The measurement is described in chapter 5.2.5 Substitute leakage.

SUB. LEAKAGE	06:00 (
l:mA	
Out:30.0V Lim:3.50mA Tim: 5s	**

Figure 6.8: VDE Organizer – Substitute leakage starting screen

Options if Appliances with heating elements is set:
--

¥ 1,4	Sets power of heating elements.

Note:

• The leakage current limit is automatically set on base of set appliance power. There are no special options to be set if other Appliance type is set.



Figure 6.9: VDE Organizer – Substitute leakage result screen

There are no special options to be set in the Substitute leakage result screen.

6.1.1.6 Differential leakage measurement

The measurement is described in chapter 5.2.8 Differential leakage.

DIFF LEAKAGE	06:00 0
l:mA	
P:kVA	
Lim:3.50mA Tim: 5s	20

Figure 6.10: VDE Organizer – Differential leakage starting screen

Options if Appliances with heating elements is set:

A/ ∀ Sets power of heating elements.

Note:

• The leakage current limit is automatically set on base of set appliance power.

There are no special options to be set if other Appliance type is set.



Figure 6.11: VDE Organizer – Differential leakage result screen

There are no special options to be set in the Differential leakage result screen.

6.1.1.7 Insulation resistance - P measurement

This test is offered if it is applicable according to the VDE Organizer setting. The measurement is described in chapter *5.2.4 Insulation resistance - P*.

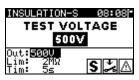


Figure 6.12: VDE Organizer autotest – Insulation resistance - P starting screen

Options in Insulation resistance-P starting screen:

ŇO	To be set if insulation test is not applicable
YES	To be set if insulation test is applicable
500 V	Standard test voltage

250 V

To be set if overvoltage protection devices are installed or SELV/ PELV protection measures.

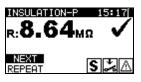


Figure 6.13: VDE Organizer – Insulation resistance - P result screen

Options in Insulation resistance - P result screen:NEXTProceeds with the next measurement.

REPEAT Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Lowest result will be stored.

6.1.1.8 Selection of touch leakage current test method

The touch leakage test is offered if it is applicable according to the VDE Organizer setting. If more test methods are possible the applicable touch leakage current test method must be set first.

Options are Touch leakage and Substitute leakage-P.

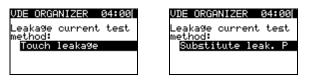


Figure 6.14: Touch leakage current test method selection screen

6.1.1.9 Substitute leakage - P current measurement

The measurement is described in chapter 5.2.6 Substitute leakage - P.

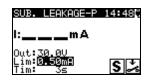


Figure 6.15: VDE Organizer – Substitute leakage - P starting screen

There are no special options in the Substitute leakage - P starting screen.



Figure 6.16: VDE Organizer – Substitute leakage - P result screen

Options in Substitute leakage - P result screen:

NEXT Proceeds with the next measurement.

REPEAT Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Highest result will be stored.

6.1.1.10 Touch leakage measurement

The measurement is described in chapter 5.2.9 Touch Leakage.



Figure 6.17: VDE Organizer – Touch leakage starting screen

There are no special options in the Touch leakage - starting screen.



Figure 6.18: VDE Organizer – Touch leakage result screen

Options in Touch leakage result screen:

NEXT Proceeds with the next measurement.

REPEAT Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Highest result will be stored.

6.1.1.11 RCD test

This test is offered if it is applicable according to the VDE Organizer setting. The measurement is described in chapter *5.2.10 (P)RCD test.*

Options in VDE organizer starting screen:

NO To be set if RCD test is not applicable.

RCD

To be set if RCD test is applicable.

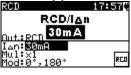


Figure 6.19: VDE Organizer – RCD starting screen

Options in RCD starting screen: ▲/ ✓ Sets nominal RCD value

Note:

• The test mode is automatically set to Single test, $1xI_{\Delta N}$, both polarities.

RCD	18:24	
×1∶39.3m≤	28.9ms	
NEXT	U:0V	ت ت

Figure 6.20: VDE Organizer – RCD result screen

There are no special options in the RCD result screen. 6.1.1.12 Functional test



Figure 6.21: VDE Organizer – Functional test result screens

Options in Functional test result screen:

PASS / FAIL To be applied manually.

Option if General or Appliance with heating elements is set:

POWER Starts Power test. The measurement is described in chapter *5.2.11 Power test.*

Option if IEC leads, multiple outlets without electronic parts is set:

POLARITY Starts Polarity test. The measurement is described in chapter 5.2.7 *Polarity test*

Note:

1/ ------

 After Power or Polarity test is completed, ESC key should be pressed to return to Functional test result screen.

6.2 Custom autotest

In the autotest custom menu user-defined autotest procedures can be performed via the PC SW PATLink PRO. Up to 50 custom autotest sequences can be pre-programmed in this autotest mode.

Commonly used pre-programmed autotest sequences are added to the list by default.

The custom sequences can be also uploaded from the PC via PC SW PATLink PRO. Refer to chapter *8 Communication* for more information.

New custom sequences can be also uploaded from the VDE Organizer. Refer to chapter 7 *Working with autotest results* for more information.

The pre-programmed sequences can be restored to default sequences by selecting *Initial settings* in *Setup menu*.

Select Custom Autotest function in Main menu.

CUSTOM AUTOTEST 15: 200
Kl_1_Iso
K1_1_ISO_BLT
Kl_1_Ia
Kl_1_Ia_BLT
↓ ^{K1_2_Iso}

Figure 6.22: Custom autotest menu

Keys:	
A I V	Selects the custom autotest.
START	Starts the selected custom autotest. See chapter 6.5 Carrying out autotest sequences (Code, Simple and Custom).
ESC	Returns to Main menu.

Note:

 If more than 50 autotests are saved, »Out of custom autotest memory« message is displayed.

6.3 Simple test

Simple test sequences are commonly used pre-programed autotest sequences with possibility of fast testing. *Fast testing mode* can be enabled in *Test speed setup* function in *Setup menu*. Refer to chapter *4.8.5 Test speed setup* for more information.

Select Simple test function in Main menu.

SIMPLE TEST	06:00
CLASS I	
CLASS II CLASS III	

Figure 6.23: Simple test menu

Keys:

neys.	
A/A	Selects the test sequence from the list
START	Starts the selected test. See chapter 6.5 Carrying out autotest sequences (Code, Simple and Custom).
ESC	Returns to Main menu.

Note:

• Test functions and limits of Simple tests are listed in *Appendix C*

6.4 Code Autotest

Code Autotest menu supports operation with pre-defined test codes, barcodes and RFID tags.

The instrument supports the following functions:

- manual selection of pre-defined autotest shortcut codes;
- reading pre-defined autotest shortcut codes from barcode labels;
- reading pre-defined autotest shortcut codes from RFID tags;
- reading appliance ID numbers from barcode labels;
- reading appliance ID, name, Re-test date, and Location from RFID tags;
- reading pre-defined autotest shortcut codes and appliance ID numbers from barcode labels (double barcode format);
- programming empty RFID tags;
- reading and executing pre-defined autotest shortcut bar codes and QR codes using Bluetooth communication with android application on mobile devices;
- reading appliance ID, name, Re-test date, and Location from QR codes.

Refer to *Appendix A Barcode and QR code formats* for more information regarding barcode and QR code labels.

Reading a Code autotest sequence (with barcode scanner, RFID reader/writer or manually)

Connect barcode scanner or RFID reader/writer to the instrument RS232 / PS2 connector first.

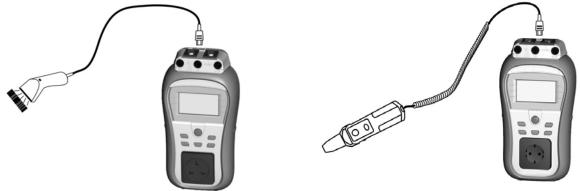


Figure 6.24: Connection of the barcode scanner and RFID reader/writer

Set RS 232 communication port using **Communication** function in **Setup menu.** Select Code Autotest in Main menu. The latest received or set autotest sequence name and its code is displayed. A new autotest sequence (received from the barcode scanner or RFID reader/writer) will be accepted by the instrument (refer to *Appendix* for available autotest sequences and its codes). A successful receive of the barcode or RFID tag is confirmed by two short confirmation beeps.

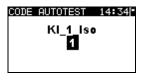


Figure 6.25: Code autotest menu

The autotest sequence and its code can also be set manually.

Keys:

AIV	Manually selects autotest sequence by setting its code.	
TEST	ST Starts selected autotest sequence. Refer to chapter 6.5 Carrying out autotest sequences (Code, Simple and Custom).	
ESC	Returns to Main menu.	

Reading appliance ID number with barcode scanner or RFID reader/writer

When the instrument is in the Save results menu, appliance ID can be scanned from a barcode label with the barcode reader or can be read from RFID tag with the RFID reader/writer. A successful receive of the barcode or RFID tag is confirmed by two short confirmation beeps.

Reading and executing a Code autotest sequence (Android application on mobile devices)

Pair the instrument with the mobile device (Smart phones, Tablets). Using PATLink Android application autotest sequence QR codes or barcodes can be scanned and tests can be executed remotely.

For more information refer to Chapter 8.3 *Bluetooth communication* and *PATLink Android instructions*.

6.5 Carrying out autotest sequences (Code, Simple and Custom)

General meaning of keys during Code, Simple and Custom autotest sequences:

TAB, A/V	Set option. Set limit value in selected (highlighted) item.	
ESC	Cancels autotest sequence and returns to the autotest menu (Code,	
	Simple or Custom) without changes.	
TEST	Starts / repeats selected measurement or proceeds to the next step.	

Notes:

- If any of the inspections are marked as failed or if any test fails the test sequence is stopped and the instrument automatically goes to the *Result* menu.
- If a test parameter (limit, duration, output voltage) is changed the setup is valid only for the particular test.
- Codes of test sequences with implemented substitute tests are marked with (*).

6.5.1 Visual inspection

Measurement is described in chapter 5.2.1 Visual inspection.



Figure 6.26: Visual test menu

Options in Visual inspection:

PASS / FAIL To be applied manually.

6.5.2 Earth continuity resistance measurement

The test is offered if it is applicable according to the autotest setting. The Earth continuity starting screen is displayed first. Measurement and options in Earth continuity starting screen are described in chapter *5.2.2 Earth continuity resistance*.

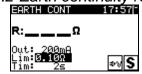


Figure 6.27: Earth continuity starting screen

After the measurement is carried out the Earth continuity result screen is displayed.



Figure 6.28: Earth continuity result screen

Options in Earth continuity result screen:

NEXT Proceeds to next step.

REPEAT Repeat the test (use in case of multiple earthed points). Highest result will be stored.

6.5.3 Insulation resistance measurement

The test is offered if it is applicable according to the autotest setting. The Insulation starting screen is displayed first. Measurement and options in Insulation starting screen are described in chapter *5.2.3 Insulation resistance*.

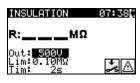


Figure 6.29: Insulation resistance starting screen

After the measurement is carried out the Insulation result screen is displayed.

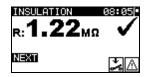


Figure 6.30: Insulation result screen

There are no special options to be set in the Insulation resistance result screen.

6.5.4 Substitute leakage measurement

The test is offered if it is applicable according to the autotest setting. The Substitute leakage current starting screen is displayed first. Measurement and options in Substitute leakage starting screen are described in chapter *5.2.5 Substitute leakage*.

SUB. LEAKAGE	07:45
l:mA	
Out:30.0V Lim:0 .50m Tim: 30s	*

Figure 6.31: Substitute leakage starting screen

After the measurement is carried out the Substitute leakage result screen is displayed.

SUB. LEAKAGE	08:06
1: 0.19 mA	✓
NEXT	**

Figure 6.32: Substitute leakage result screen

There are no special options to be set in the Substitute leakage result screen.

6.5.5 Differential leakage measurement

The test is offered if it is applicable according to the autotest setting. The Differential leakage current starting screen is displayed first. Measurement and options in Differential leakage starting screen are described in chapter *5.2.8 Differential leakage*.

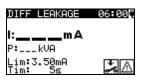


Figure 6.33: Differential leakage starting screen

After the measurement is carried out the Differential leakage result screen is displayed.





There are no special options to be set in the Differential leakage result screen.

6.5.6 Insulation resistance - P measurement

The test is offered if it is applicable according to the autotest setting. The Insulation resistance - P starting screen is displayed first. Measurement and options in Insulation resistance - P starting screen are described in chapter *5.2.4 Insulation resistance - P*.

INSULATION-F	2 14:48
R:M	Ω
Out: <u>5000</u> Lim:0.10MΩ Tim: 3s	S La

Figure 6.35: Insulation resistance - P starting screen

After the measurement is carried out the Insulation resistance - P result screen is displayed.



Figure 6.36: Insulation resistance - P result screen

Options in Insulation resistance - P result screen:

NEXT Proceeds with the next measurement.

REPEAT Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Lowest result will be stored.

6.5.7 Substitute Leakage - P measurement

The test is offered if it is applicable according to the autotest setting. The Substitute leakage - P starting screen is displayed first. Measurement and options in Substitute leakage - P starting screen are described in chapter *5.2.6 Substitute leakage - P*.



Figure 6.37: Substitute leakage - P starting screen

After the measurement is carried out the Substitute leakage - P result screen is displayed.



Figure 6.38: Substitute leakage - P result screen

Options in Substitute leakage - P result screen:

NEXT Proceeds with the next measurement.

REPEAT Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Highest result will be stored.

6.5.8 Touch Leakage measurement

The test is offered if it is applicable according to the autotest setting. The Touch leakage - starting screen is displayed first. Measurement and options in Touch leakage screen are described in chapter *5.2.9 Touch leakage*.

TOUCH LEAKAG	E 14:58
l:m4	4
P:kVA	
Lim: <mark>0.50mA</mark> Tim: 3s	S 🎿 🛆

Figure 6.39: Touch leakage starting screen

After the measurement is carried out the Touch leakage result screen is displayed.



Figure 6.40: Touch leakage result screen

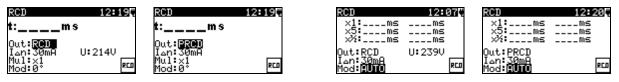
Options in Touch leakage result screen: **NEXT** Proceeds with the next measurement.

REPEAT Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Highest result will be stored.

6.5.9 (P)RCD test

The test is offered if it is applicable according to the autotest setting. The (P)RCD test starting screen is displayed first.

Measurement and options in (P)RCD test starting screen are described in chapter *5.2.10 RCD test.*



(P)RCD single test menus

(P)RCD autotest menu

Figure 6.41: (P)RCD test starting screen

After the measurement is carried out the (P)RCD test result screen is displayed.

RCD	20:03	RCD	19:520
× <u>1</u> :39.5ms	28.9ms	× <u>1</u> :29.2ms	2 <u>1</u> .0ms
×5:15.3m≤ ×½:>300m≤	9.9ms >300ms	×5:10.1ms ×%:>300ms	15.4ms >300ms
0		0	× V V
Lon: JAme	0:2410		
Mod: AUTO		Mod AUTO	

Figure 6.42: Example of Custom / Code Autotest – (P)RCD test result screen

There are no special options in the (P)RCD result screen.

6.5.10 Polarity test

The test is offered if it is applicable according to the autotest setting. The Polarity test starting screen is displayed first. Measurement and options in Polarity test starting screen are described in chapter *5.2.7 Polarity test*.

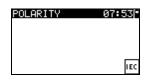


Figure 6.43: Polarity test starting screen

After the measurement is carried out the Polarity test result screen is displayed.

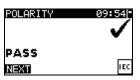


Figure 6.44: Polarity test result screen

There are no special options in the Polarity test starting screen.

6.5.11 Power test

The test is offered if it is applicable according to the autotest setting. The Power starting screen is displayed first. Measurement and options in Power starting screen are described in chapter *5.2.11 Power test*.

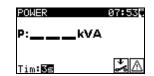


Figure 6.45: Power starting screen

After the measurement is carried out the Power result screen is displayed.



Figure 6.46: Power result screen

There are no special options to be set in the Power result screen.

6.5.12 Clamp current measurement

The test is offered if it is applicable according to the autotest setting. The Clamp current starting screen is displayed first. Measurement and options in Clamp current starting screen are described in chapter *5.2.13 Clamp current measurement*.

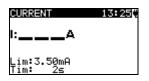


Figure 6.47: Clamp current starting screen

After the measurement is carried out the Clamp current result screen is displayed.

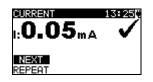


Figure 6.48: Clamp current result screen

There are no special options to be set in the Clamp current result screen.

6.5.13 Functional test

The test is offered if it is applicable according to the autotest setting. The Functional test starting screen is displayed first. For more information regarding measurement and test parameters see chapter *5.2.14 Functional test*.



Figure 6.49: Functional result screens

Options in Functional test result screen:PASS / FAILTo be applied manually.POWERStarts Power test.

6.6 Handling autotest results

After the Code, Simple or Custom autotest is finished, the Main autotest result screen will be displayed including an overall \checkmark / \times (PASS / FAIL) indication.

AUTOTEST RESUL.	.11:31
OVERALL:	\checkmark
VIEW RESULTS	
NEW TEST	
↓ SAVE RESULTS	

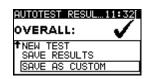


Figure 6.50: Main autotest result screen

Options in Autotest results screen:

VIEW RESULTS	Views individual results.
NEW TEST	Returns to Code, Simple or Custom menu.
SAVE RESULTS	Saves Autotest results.
SAVE AS CUSTOM	Refer to chapter <i>7.1 Saving autotest results</i> for more information regarding saving of autotest results. Saves test setup as Custom autotest. Refer to chapter <i>6.2</i>
	<i>Custom autotest</i> for more information regarding Custom autotests.
ESC	Returns to Code, Simple or Custom menu.

Viewing autotest results

In the *View results* screen performed tests, results and their PASS / FAIL status are displayed. Furthermore the selected test results can be displayed with full details.

Options in View result screen:

▲ / ▼ Selects result of measurement.	
TEST	Enters selected result of measurement (to be displayed in full details).
ESC	Returns to previous result screen.

VIEW RESUL	TS 18:40["
VISUAL	~
E.CONT.	0.01A 🗸
INS	≥200MΩ 🖌
SUB.L.	0.01mA 🗸
FUNCT.	~

 ERRTH CONT.
 18:4%

 R:
 0.03Ω
 ✓

 Out:
 200mA
 ✓

 Lim:0.30Ω
 ✓
 ✓

Figure 6.51: Overall result screen

Figure 6.52: Detailed result screen

Saving autotest as Custom autotest

In the Save as custom screen last autotest can be stored as CUSTOM AUTOTEST.

∀/ A, TEST	Edit autotest name.	
MEM (SAVE)	Saves autotest name.	
ESC (DEL)	Deletes last character of autotest name.	
ESC (CANCEL)	Returns to the previous menu.	

INSERT TE	XT 00:01[*
AUTOTEST A57 <u>7</u>	NAME:
MEM SAVE	ESC DEL

Figure 6.53: Save as custom screen

7 Working with autotest results

7.1 Saving autotest results

After selecting **Save results** in **Autotest results** menu, the autotest results will be stored in the internal memory of the instrument.

The appliance ID number, NAME, Re-Test period and LOCATION can be added to the test results before the results are saved:

SAVE RESULTS 15:31	SAVE RESULTS 12:24
APPLIANCE ID:	APPLIANCE ID:
JO	31414
FREE: 98.5%	FREE: 97.2%
ESCICANCEL	MEMIOK ESCIDEL

Figure 7.1: Save results menu (Appliance ID)

Keys:

∀/ A, TEST	Edit Appliance ID data.	
MEM (OK)	Saves Appliance ID.	
ESC (DEL)	Deletes last character of Appliance ID.	
ESC (CANCEL)	Returns to the previous menu.	

An Appliance ID of up to 14 alphanumeric characters can be entered. The Appliance ID can also be scanned with a barcode scanner, RFID reader/writer or using PATLink android application on mobile devices (QR codes).

SAVE RESULTS 12:510	SAVE RESULTS 12:51
APPLIANCE NAME:	APPLIANCE NAME:
D	Cooker
TABLIST FREE:99.7%	TABLIST FREE:99.72
MEM SAVE ESC CANCEL	MEM SAVE ESC DEL

Figure 7.2: Save results menu (Appliance NAME)

Keys:

∀ / A, TEST	Edit Appliance NAME data.
TAB (LIST)	Offers last forty entered names with optional filtering.
ESC (DEL)	Deletes last character of Appliance NAME.
ESC (CANCEL)	Returns to the previous menu.
MEM (OK)	Saves Appliance NAME.

An Appliance NAME of up to 14 alphanumeric characters can be entered. Using TAB key last 40 names can be selected from the LIST. Filter is applied to the LIST if any character is written on Appliance NAME. The Appliance NAME can also be scanned with a barcode scanner, RFID reader/writer or using PATLink android application on mobile devices (QR codes).

APPLIANCE NAME	12:52
Iron	
Lamp	
Cooker	
DVD Player Television	
Television	

Figure 7.3: List menu (Appliance NAME)

The Re-Test period can be entered.

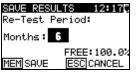


Figure 7.4: Save results menu (Re-Test period)

Keys:

∀/ A, TEST	ST Set Re-Test period in months.	
ESC (CANCEL)	Returns to the previous menu.	
MEM (SAVE)	Saves Re-Test period and returns to Autotest result menu.	

The Re-Test period can also be scanned with RFID reader/writer or using PATLink android application on mobile devices (QR codes).

Notes:

- The instrument remembers last 40 entered appliances names.
- Re-Test period from 1 to 60 months can be set or disabled (---)

The LOCATION of appliance can be entered.

SAVE RESUL	_TS	10:19
LOCATION:		
NAL4		
	FR	EE:99.4%
MEM OK	ES(CLR

Figure 7.5: Save results menu (Location)

Keys:

∀ / A, TEST	Edit Location.
MEM (OK)	Saves Location and returns to Autotest Results menu.
ESC (DEL)	Deletes last character of Location.
ESC (CANCEL)	Returns to the previous menu.

An Appliance LOCATION of up to 14 alphanumeric characters can be entered. The Appliance LOCATION can also be scanned with a barcode scanner, RFID reader/writer or using PATLink android application on mobile devices (QR codes).

7.2 Recalling results

Saved autotest results can be recalled, printed or deleted from the *Memory* menu. Enter the *Memory* menu from the *Setup* menu.

MEMORY	07:03
RECALL RE	SULTS
DELETE RE CLEAR ALL PRINTER	
RFID	

Figure 7.6: Memory menu

To enter the Recall results menu select Recall results in Memory menu. A list of Appliance ID's and NAMES are displayed in a chronological order (last performed measurement is displayed at the bottom of the list). In the lower display the following data is displayed:

- Appliance ID, NAME;
- Date and time of the selected test; ۲
- The overall \checkmark / \times status of the selected test. •

RECALL RESULTS 12:36
†31414,DVD Player
55678,Cooker
008346,Lamp
442367, Iron
55678,Cooker Jan.1,2000 12:29 🗸
Jan.1,200012:29 🗸

Figure 7.7: Recall results menu

Keys:

A/∀, TEST	Enters View results menu for viewing autotest results.
ESC	Returns to Memory menu.

Note:

MEM key can be used as shortcut to enter *Recall results* menu. •

In the View results screen performed tests, results and their PASS / FAIL status are displayed. Furthermore the selected test results can be displayed with full details.

CONT 0.030 >200MΩ SUB. FUNCT.

Figure 7.8: Overall result screen



Figure 7.9: Detailed result screen

Options in View result screen:

V/A	Selects result of measurement.
TEST	Enters selected result of measurement (to be displayed in full details).
ESC	Returns to previous result screen.

. .

7.3 Deleting individual autotest results

To enter the Delete results menu select **Delete results** in **Memory** menu. A list of Appliance ID's and NAMES are displayed in a chronological order (last performed measurement will be displayed at the bottom of the list).

In the lower window of the display the following data is displayed:

- Appliance ID, NAME;
- date and time of the selected test;
- the overall ✓ / × status of the selected test.

DELETE RESULTS 12:50
24358,Television
31414,DVD Player
55678,Cooker
↓008346,LamP
31414,DVD Player
Jan.1,200012:29 🗸

Figure 7.10: Delete results menu

Keys:	
V/A	Select autotest result to be deleted.
TEST	Deletes selected autotest result.
ESC	Returns to Setup menu.

7.4 Clearing complete memory content

Select CLEAR ALL MEMORY in Memory menu. A warning will be displayed.

CLEAR ALL MEMO...13:097 All saved results will be lost

Figure 7.11: Clear all memory menu

Keys:	
TEST	Confirms clearing of complete memory content.
ESC	Exits back to Memory menu without changes.

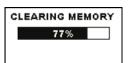


Figure 7.12: Clearing memory in progress

7.5 Printing labels and writing RFID tags with autotest results

Labels can be printed and RFID tags can be written from the *Autotest Results* and *Setup/ Memory* menus.

7.5.1 Printing labels / writing in RFID tags from Autotest Results menu

To print a label or write data to a TAG an Autotest must be saved first. Refer to chapter 7.1 *Saving Autotest results for more information*.

AUTOTEST RESUL	10:14
OVERALL:	\checkmark
SAVE AS CUSTOR PRINTER	1
RFID	

Figure 7.13: Autotest result screen

Options in Autotest results screen (after Autotest is saved):

VIEW RESULTS	Views individual results.
NEW TEST	Returns to Code, Simple or Custom menu.
SAVE AS CUSTOM	Saves test setup as Custom autotest. Refer to chapter 6.2 Custom autotest for more information regarding Custom autotests.
PRINTER	Proceeds to menu for printing barcode or QR code labels.
<i>RFID</i>	Proceeds to menu for writing RFID tag.
ESC	Returns to Code, Simple or Custom menu.

7.5.2 Printing labels / writing in a RFID tag from Setup/ Memory menu

To print a label / write a TAG select *Printer* or *RFID* in *Memory* menu.

A list of Appliance ID's and NAMES is displayed in a chronological order (last performed measurement will be displayed at the bottom of the list).

In the lower window of the display the following data is displayed:

- Appliance ID, NAME;
- date and time of the selected test;
- the overall \checkmark / \times status of the selected test.

PRINT DATA	12:43
24358, Televis:	
31414,DVD 01a	der
55678,Cooker	
↓008346,LamP	
31414,DVD_0laye	er.
Jan.1,2000 12:2	29 🖌

RFID 12:4	3
24358, Television	
31414,DVD Player	
55678,Cooker	
↓008346,LamP	
31414,DVD_Player	
Jan.1,2000 12:29	~

Figure 7.14: Print label / write TAG menu

Keys:	
V/A	Selects saved individual result.
TEST	Confirms selected result and enters <i>Printer</i> or <i>RFID</i> menu.
ESC	Exits back to Memory menu without changes.

In the *Printer* menu four options can be selected: Print simple label, Print label, Print results, and Print QR label. Possible options depend on the selected printer.

PRINTER	10:38	PRINTER	R 10:38
	SIMPLE LABEL	PRINT	SIMPLE LABEL
PRINT PRINT	LABEL RESULTS	PRINT PRINT	LABEL QR LABEL

Figure 7.15: Options in Printer menu

Print Simple label

A simple appliance label will be printed.

Print label

An appliance label with barcode will be printed.

Print results

All the data stored at the specified location will be printed. That includes Appliance ID, Appliance NAME, Test date and time, Overall and individual measurement result (Pass or Fail), individual measurement values, limits and other settings.

Print QR label

An appliance label with QR code will be printed.

Keys:

1.090.	
V/A	Selects action.
TEST	Confirms and executes selected action.
ESC	Exits back to previous menu without changes.

In the *RFID* menu a RFID tag can be written.

RFID		10:43
WRITE	RFID	TAG

Figure 7.16: RFID tag menu

Write RFID tag

The test information is copied to RFID reader/writer. Pressing a **R/W** key on the RFID reader/writer writes Appliance ID, name, Test Date, Time, Location and autotest code to RFID tag (for detailed information see RFID reader/writer instruction manual).

Keys:

TEST	Confirms and executes selected action.
ESC	Exits back to previous menu without changes.

8 Communication

There are three communication interfaces for communication with PC and other external devices: USB, RS232 and Bluetooth. See chapter *4.8.3 Communication* for more information.

8.1 USB communication

How to establish an USB link:

- COM PORT: USB should be selected in Communication menu. Connect the PC
 USB port to the instrument USB connector using the USB interface cable.
- Switch on the PC and the instrument.
- Run the PATLink PRO program.
- Set communication port and baud rate speed.
- The instrument is prepared to upload / download data to the PC.

Notes:

- USB drivers should be installed on PC before using the USB interface. Refer to USB installation instructions available on installation CD.
- USB interface is recommended for communication with the PC software because of the high communication speed.

8.2 RS232 communication

How to establish an RS232 link:

- COM PORT: RS232 should be selected in Communication menu. Connect the COM port of PC or external device to the instrument PS/2 connector using the PS/2 - RS232 serial communication cable.
- Switch on the PC (Run the PATLink PRO program) or external device and the instrument.
- Set communication port and baud rate speed on PC or external device (optionally)
- The instrument is prepared to upload / download data to the PC.

How to establish an RS232 link between instrument and Zebra TL2824 Plus printer:

- Connect the COM port of Zebra TL2824 Plus printer with modified MINI GENDER CHANGER and PS/2 - RS232 serial communication cable.
- Switch on the Zebra TL2824 Plus printer and the instrument.
- Be sure that settings in Communication menu (see chapter 4.8.3 Communication) are as following:

COM PORT: RS232 PRINTER: ZEBRA

• The instrument and the printer are ready to communicate.

8.3 Bluetooth communication

The internal Bluetooth module enables easy communication via Bluetooth with PC and Android devices.

How to configure a Bluetooth link between instrument and PC:

- Switch On the instrument.
- On PC configure a Standard Serial Port to enable communication over Bluetooth link between instrument and PC. Usually no code for pairing the devices is needed.
- Run the *PATlinkPRO* program.
- Set communication port and baud rate speed.
- The instrument is prepared to communicate with the PC.

How to configure a Bluetooth link between instrument and Android device:

- Switch On the instrument.
- Some Android applications automatically carry out the setup of a Bluetooth connection. It is preferred to use this option if it exists. This option is supported by Metrel's Android applications.
- If this option is not supported by the selected Android application then configure a Bluetooth link via Android device's Bluetooth configuration tool. Usually no code for pairing the devices is needed.
- The instrument and Android device are ready to communicate.

Notes:

- Sometimes there will be a demand from the PC or Android device to enter the code. Enter code 'NNNN' to correctly configure the Bluetooth link.
- The name of correctly configured Bluetooth device must consist of the instrument type plus serial number, eg. *MI 3309 BT-12240429I*. If the Bluetooth module got another name, the configuration must be repeated.
- In case of serious troubles with the Bluetooth communication it is possible to reinitialize the internal Bluetooth module. The initialization is carried out during the Initial settings procedure. In case of a successful initialization "INTERNAL BLUETOOTH SEARCHING OK!" is displayed at the end of the procedure. See chapter 4.8.9 Initial settings.

How to configure a Bluetooth link between instrument / Android device / Zebra TL2824 Plus printer:

- Switch Off and On the instrument.
- Switch On the printer. The Bluetooth dongle A 1436 must be inserted to the printer's COM port.
- Be sure that settings in Communication menu (see chapter 4.8.3 Communication) are as following:
 - PRINTER: ZEBRA BT

PRN NAME: ZebraPRN

The dongle should be properly initialized (see chapter 4.8.3 Communication).

- If printing from Android device be sure that Zebra printer is selected in the Metrel Android application as the Bluetooth printer. The configuration tool is available in the Metrel's Android application.
- The instrument and printer are ready to communicate.

Notes:

- The name of a correctly configured Bluetooth device must consist of the instrument type plus serial number, eg. *MI 3309 BT-12240429D*.
- The name of a correctly configured Bluetooth device for the Zebra printer is ZebraPRN.

9 Maintenance

9.1 Periodic calibration

It is essential that all measuring instruments are regularly calibrated in order for the technical specification listed in this manual to be guaranteed. We recommend an annual calibration. The calibration has to be done by an authorized technical person only.

9.2 Replacing the fuses

The DeltaGT MI 3309 BT instrument contains two accessible fuses:

 F1, F2 fuse type: T 16 A / 250 V, 20×5 mm, breaking capacity 1500 A General input protection fuses.

Warnings:

- Disconnect all measuring accessories, mains supply and power off the instrument before opening the battery or fuse compartment cover, hazardous voltage inside!
- Replace blown fuse with same type only, otherwise the instrument may be damaged and / or operator's safety impaired!

Position of fuses F1, F2 can be seen in *Figure 2.2* in chapter 2.2 *Connector panel*.

9.3 Service

For repairs under or out of warranty please contact your distributor for further information. Unauthorized person is not allowed to open the DeltaGT instrument. There are no user replaceable parts inside the instrument.

9.4 Cleaning

Use a soft cloth, slightly moistened with soapy water or alcohol to clean the surface of the instrument. Leave the instrument to dry totally before using it.

Notes:

- Do not use liquids based on petrol or hydrocarbons!
- Do not spill cleaning liquid over the instrument!

10 Instrument set and accessories

Standard set of the instrument

- Instrument MI 3309 BT DeltaGT
- Test probe, black
- Crocodile clip, black
- Test lead, 1.5 m, black
- 2 x IEC cord, 1.5 m
- NiMH batteries, type HR 6 (size AA),, 6 pcs
- USB cable
- RS232 PS/2 cable
- PC SW PATLink PRO
- Instruction manual
- Small soft carrying bag
- Calibration certificate

Optional accessories

See the attached sheet for a list of optional accessories that are available on request from yours distributor.

Appendix A – Barcode and QR code formats

Barcode formats

The instrument DeltaGT supports two barcode formats (single and double).

Autotest code and appliance ID

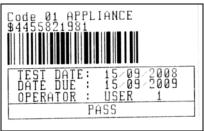
Autotest codes are represented as a three digits code. These autotest codes can also be represented by the barcode.

Using the barcode scanner, the instruments can accept autotest code from barcode label.



Autotest code

Also appliance ID can be read from barcode label.





barcode system: single

barcode system: double

Examples of appliance labels

A01Autotest code\$Separator

4455821981 Appliance ID

Note:

 Special character »\$« between autotest code and appliance ID is used to distinguish code from appliance ID.

QR code formats

The instrument DeltaGT also supports QR code format.

Autotest code, Appliance ID, Appliance name, Re-Test period, Location, and results of tests can be represented by QR code.



Example of QR code

Appendix B – Pre-programmed autotests (GER)

Autotest shortcut code		A01	A02	A03	A04
		KI_1_lso	KI_1_lso_BLT	KI_1_la	KI_1_la_BLT
Visual test	Visual test		\checkmark	\checkmark	\checkmark
Forth	Output	200 mA	200 mA	200 mA	200 mA
Earth continuity	Limit	0.30 Ω	0.30 Ω	0.30 Ω	0.30 Ω
communy	Time	5 s	5 s	5 s	5 s
	Output	500 V	500 V	×	×
Insulation	Limit	1.00 MΩ	1.00 MΩ	×	X
	Time	5 s	5 s	×	X
la sul sti su	Output	×	500 V	×	×
Insulation (probe)	Limit	×	2.00 MΩ	×	X
(prope)	Time	×	5 s	×	X
	Output	40 V	40 V	×	×
Sub. leakage	Limit	3.50 mA	3.50 mA	×	X
	Time	5 s	5 s	×	×
Sub. leakage	Output	×	40 V	×	X
(probe)	Limit	×	0.50 mA	×	×
(probe)	Time	×	5 s	×	×
Differential	Output	×	×	230 V	230 V
leakage	Limit	×	×	3.50 mA	3.50 mA
leakaye	Time	×	×	180 s	180 s
Touch	Output	×	×	×	230 V
leakage	Limit	×	×	×	0.50 mA
•	Time	×	×	×	180 s
Functional tes	t	\checkmark	\checkmark	\checkmark	\checkmark
	Output	230 V	230 V	230 V	230 V
Power*	Limit	×	×	×	×
	Time	180 s	180 s	180 s	180 s
TRMS clamp	Output	×	×	×	×
current		×	×	×	×
	Time	×	×	x	×
Polarity test		X	×	×	×

Pre-programmed autotest sequences table

Autotest shortcut code		A05	A06	A07	A08
		KI_2_lso	KI_2_lbs	KI_1_Isola	KI_1_IsolaBLT
Visual test		$\overline{\mathbf{V}}$	\checkmark	\checkmark	\checkmark
Corth	Output	×	×	200 mA	200 mA
Earth continuity	Limit	×	×	0.30 Ω	0.30 Ω
continuity	Time	×	×	5 s	5 s
	Output	x	×	500 V	500 V
Insulation	Limit	×	×	1.00 MΩ	1.00 MΩ
	Time	×	x	5 s	5 s
	Output	500 V	×	x	500 V
Insulation	Limit	2.00 MΩ	x	X	2.00 MΩ
(probe)	Time	5 s	x	X	5 s
	Output	×	×	×	×
Sub. leakage	Limit	×	x	×	×
	Time	×	×	X	×
Sub lookogo	Output	40 V	×	X	×
Sub. leakage (probe)	Limit	0.50 mA	×	X	×
(probe)	Time	5 s	×	X	×
Differential	Output	×	×	230 V	230 V
leakage	Limit	×	×	3.50 mA	3.50 mA
leanage	Time	×	×	180 s	180 s
Touch	Output	×	230 V	X	230 V
leakage	Limit	×	0.50 mA	×	0.50 mA
, , , , , , , , , , , , , , , , , , ,	Time	×	180 s	×	180 s
Functional tes	st	\checkmark	$\overline{\mathbf{A}}$	$\overline{\mathbf{A}}$	$\overline{\mathbf{A}}$
	Output	230 V	230 V	230 V	230 V
Power*	Limit	×	×	×	×
	Time	180 s	180 s	180 s	180 s
TRMS clamp	Output	x	×	x	×
current	Limit	×	×	x	×
Current	Time	×	×	×	×
Polarity test		×	×	X	×

Autotest shortcut code		A09	A10	A11	A12
		KI_2_Isolbs	KI_2	KI_3_lso	KI_3
Visual test	Visual test		\square	\square	\square
Earth	Output	×	×	×	×
continuity	Limit	×	×	×	×
continuity	Time	×	×	×	×
	Output	×	×	×	×
Insulation	Limit	×	×	×	×
	Time	×	×	×	×
Inculation	Output	500 V	×	500 V	×
Insulation (probe)	Limit	2.00 M Ω	×	0.250 MΩ	×
(probe)	Time	5 s	×	5 s	×
	Output	×	×	×	×
Sub. leakage	Limit	×	×	×	×
	Time	×	×	×	×
Sub lookage	Output	×	×	×	×
Sub. leakage (probe)	Limit	×	×	×	×
(probe)	Time	×	×	×	×
Differential	Output	×	×	×	×
Differential	Limit	×	×	×	×
leakage	Time	×	×	×	×
	Output	230 V	×	×	×
Touch leakage	Limit	0.50 mA	×	×	×
_	Time	180 s	×	×	×
Functional test		$\mathbf{\overline{A}}$	\checkmark	$\overline{\mathbf{A}}$	$\mathbf{\overline{A}}$
	Output	230 V	230 V	×	×
Power*	Limit	×	×	×	×
	Time	180 s	180 s	×	×
	Output	X	×	×	×
TRMS clamp	Limit	×	×	×	×
current	Time	×	×	×	×
Polarity test		×	×	×	×

METREL GmbH VDE tester test type card

Code	Autotest seque	ence name and descriptions	Limits	Barcode
A01	KI_1_Iso	Testing according to VDE. Class 1 device. Insulation resistance and substitute leakage current measurements are applicable.		A0 1
A02	KI_1_Iso_BLT	Testing according to VDE. Class 1 device with isolated accessible cinductive parts. Insulation resistance and substitute leakage current measurements are applicable.	Insulation - P: 2.00 M Ω Sub leakage: 3.50 mA	A0 2
A03	KI_1_la	Testing according to VDE. Class 1 device. Prüfung für Differenzstrom wird eingestellt.	Earth bond: 0.30 Ω Leakage: 3.50 mA	A0 3
A04	KI_1_Ia_BLT	Testing according to VDE. Class 1 device with isolated accessible conductive parts. Prüfungen für Differenz- und Berührungsstrom werden eingestellt.	Earth bond: 0.30 Ω Leakage: 3.50 mA Touch leakage: 0.50 mA	A0 4
A05	KI_2_lso	Testing according to VDE. Class 2 device with isolated accessible conductive parts. Insulation resistance and substitute leakage current measurements are applicable.	Insulation - P: 2.00 M Ω	A0 5
A06	KI_2_lbs	Testing according to VDE. Class 2 device. Prüfung für Berührungsstrom wird eingestellt.	Touch leakage: 0.50 mA	A0 6
A07	KI_1_Isola	Testing according to VDE. <i>Class 1 device.</i> Prüfungen für Isolation und Differenzstrom werden eingestellt.	Earth bond: 0.30 Ω Insulation: 1.00 M Ω Leakage: 3.50 mA	A0 7
A08	KI_1_IsolaBLT	Testing according to VDE. Class 1 device with isolated accessible conductive parts. Prüfungen für Isolation, Differenz- und Berührungsstrom werden eingestellt.	Insulation - P: 2.00 M Ω	A0 8
A09	KI_2_lsolbs	Testing according to VDE. Class 2 device with isolated accessible conductive parts. Prüfungen für Isolation und Berührungsstrom werden eingestellt.	Insulation - Ρ: 2.00 MΩ Touch leakage: 0.50 mA	A0 9

METREL GmbH VDE tester test type card (cont'd)

A10	KI_2	Testing according to VDE. Class 2 device without any isolated accessible conductive parts.		A1 0
A11	KI_3_lso	Testing according to VDE. Class 3 device with isolated accessible conductive parts.	Insulation - Ρ: 0.25 MΩ	
A12		Testing according to VDE. Class 3 device without any isolated accessible conductive parts.		A1 2

Appendix C – Simple test codes (GER)

Simple test codes		CLASS I	CLASS II	CLASS III
Visual test		\checkmark	\checkmark	\checkmark
	Output	200 mA	×	x
Earth continuity	Limit	0.30 Ω	X	X
-	Time	5 s	X	X
	Output	500 V	X	X
Insulation	Limit	1.00 MΩ	×	X
	Time	2 s	×	X
Insulation	Output	×	500 V	500 V
(probe)	Limit	×	2.00 MΩ	0.25 MΩ
(probe)	Time	×	2 s	5 s
	Output	40 V	X	X
Sub. leakage	Limit	3.50 mA	×	x
	Time	2 s	×	×
Sub. leakage	Output	×	40 V	x
(probe)	Limit	×	0.50 mA	×
(51050)	Time	×	5 s	×
Differential	Output	×	×	×
leakage	Limit	×	×	x
leanage	Time	×	x	x
	Output	×	×	×
Touch leakage	Limit	×	×	×
	Time	x	×	×
Functional test		×	×	×
	Output	×	×	×
Power*	Limit	×	×	x
	Time	×	×	×
TRMS clamp	Output	×	×	×
current	Limit	×	×	x
	Time	x	×	×
Polarity test		×	×	×

Appendix D – Pre-programmed autotests (NL)

Autotest shortcut code		01	02	03	04
		KL_1_ALG	KL_2_ALG	KL_1_HEATERS	KL_1_PC
Visual test		\mathbf{V}	$\mathbf{\nabla}$	\checkmark	\checkmark
Corth	Output	200 mA	×	200 mA	200 mA
Earth continuity	Limit	0.30 Ω	×	0.30 Ω	0.30 Ω
continuity	Time	5 s	x	5 s	5 s
	Output	500 V	X	500 V	×
Insulation	Limit	1.00 MΩ	×	0.50 MΩ	×
	Time	5 s	x	5 s	×
Inculation	Output	×	500 V	x	x
Insulation (probe)	Limit	x	2.00 MΩ	x	x
(prope)	Time	x	5 s	×	×
	Output	×	×	40 V	×
Sub. leakage	Limit	x	x	7 mA	×
_	Time	×	×	5 s	×
Sub. leakage	Output	×	×	×	×
(probe)	Limit	×	×	×	×
(hione)	Time	×	×	×	×
Differential	Output	×	×	×	230 V
leakage	Limit	×	x	×	0.50 mA
leakaye	Time	×	×	×	120 s
Touch	Output	×	×	×	×
leakage	Limit	×	x	×	×
•	Time	×	×	×	×
Functional tes	-	\square	\mathbf{N}	\square	×
	Output		230 V	230 V	×
Power*	Limit	×	x	×	×
	Time	10 s	10 s	10 s	×
TRMS clamp	Output		x	x	×
current	LIMIL	×	×	x	×
	Time	×	×	x	x
Polarity test		X	×	X	X

Autotest shortcut code		05	06	07	08
		KL_3_ALG	KL_1_AGMD	KABEL_5M_2.5MM	KABEL_15M_2.5MM
Visual test		$\mathbf{\nabla}$	Ŋ	\square	\square
Earth	Output	×	200 mA	200 mA	200 mA
continuity	Limit	×	0.30 Ω	0.30 Ω	0.50 Ω
continuity	Time	×	5 s	5 s	5 s
	Output	×	500 V	500 V	500 V
Insulation	Limit	X	1.00 MΩ	1.00 MΩ	1.00 MΩ
	Time	x	5 s	5 s	5 s
	Output	500 V	500 V	×	×
Insulation	Limit	0.50 MΩ	2.00 MΩ	X	×
(probe)	Time	5 s	5 s	X	×
	Output	×	x	×	×
Sub. leakage	Limit	x	x	X	×
_	Time	x	X	X	×
Sub lookogo	Output	x	X	X	×
Sub. leakage (probe)	Limit	×	X	X	×
(hione)	Time	×	×	×	×
Differential	Output	×	230 V	X	×
leakage	Limit	×	1.00 mA	X	×
Теакауе	Time	×	5 s	X	×
Touch	Output	×	230 V	X	×
leakage	Limit	×	0.50 mA	X	×
leakaye	Time	×	5 s	X	×
Functional tes	st	×	×	×	×
	Output	×	×	×	×
Power*	Limit	×	×	×	×
	Time	×	×	×	×
TRMS clamp	Output	×	×	×	×
current	Limit	×	×	X	×
	Time	×	×	×	×
Polarity test		×	×	$\overline{\mathbf{A}}$	\checkmark

Autotest s	shortcut code	09	10	
		KABEL_25M_2.5MM	KABEL_50M_2.5MM	
Visual test			\checkmark	
Earth	Output	200 mA	200 mA	
continuity	Limit	0.70 Ω	1.00 Ω	
continuity	Time	5 s	5 s	
	Output	500 V	500 V	
Insulation	Limit	1.00 MΩ	1.00 MΩ	
	Time	5 s	5 s	
	Output	×	×	
Insulation	Limit	x	x	
(probe)	Time	x	x	
	Output	×	x	
Sub. leakage	Limit	x	X	
_	Time	x	x	
Cub lookers	Output	×	×	
Sub. leakage (probe)	Limit	x	×	
(prope)	Time	X	×	
Differential	Output	X	×	
leakage	Limit	×	×	
leakaye	Time	×	×	
Touch	Output	×	×	
leakage	Limit	×	×	
leakaye	Time	×	×	
Functional tes	st	×	×	
	Output	×	×	
Power*	Limit	×	×	
	Time	×	×	
TRMS clamp	Output	X	×	
current	Limit	×	×	
	Time	×	X	
Polarity test			\square	